**FUJITSU SEMICONDUCTOR
DATA SHEET**

MEMORY
CMOS
2 × 1 M × 8 BIT
SYNCHRONOUS DYNAMIC RAM

MB81F16822D-102L/-103L/-10L

CMOS 2-Bank × 1,048,576-Word × 8 Bit
Synchronous Dynamic Random Access Memory

■ DESCRIPTION

The Fujitsu MB81F16822D is a CMOS Synchronous Dynamic Random Access Memory (SDRAM) containing 16,777,216 memory cells accessible in an 8-bit format. The MB81F16822D features a fully synchronous operation referenced to a positive edge clock whereby all operations are synchronized at a clock input which enables high performance and simple user interface coexistence. The MB81F16822D SDRAM is designed to reduce the complexity of using a standard dynamic RAM (DRAM) which requires many control signal timing constraints, and may improve data bandwidth of memory as much as 5 times more than a standard DRAM.

The MB81F16822D is ideally suited for laser printers, high resolution graphic adapters, accelerators and other applications where an extremely large memory and bandwidth are required and where a simple interface is needed.

■ PRODUCT LINE & FEATURES

Parameter	MB81F16822D-102L	MB81F16822D-103L	MB81F16822D-10L
CL - t_{RCD} - t_{RP}	2 - 2 - 2 clk min.	3 - 2 - 2 clk min.	3 - 3 - 3 clk min.
Clock Frequency	100 MHz max.	100 MHz max.	100 MHz max.
Burst Mode Cycle Time	10 ns min.	10 ns min.	10 ns min.
Access Time From Clock	6 ns max. (CL = 2)	6 ns max. (CL = 3)	6 ns max. (CL = 3)
Operating Current (Two Banks Active)	160 mA max.	160 mA max.	130 mA max.
Power Down Mode Current (I_{CC2P})	150 µA max.	150 µA max.	150 µA max.
Self Refresh Mode Current (I_{CC6})	250 µA max.	250 µA max.	250 µA max.

- Single +3.3 V Supply ±0.3 V tolerance
- LVTTL compatible I/O interface
- 4 K refresh cycles every 64 ms
- Dual banks operation
- Burst read/write operation and burst read/single write operation capability
- Programmable burst type, burst length, and CAS latency
- Auto-and Self-refresh (every 15.6 µs)
- CKE power down mode
- Output Enable and Input Data Mask
- Low power version

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■ PACKAGE

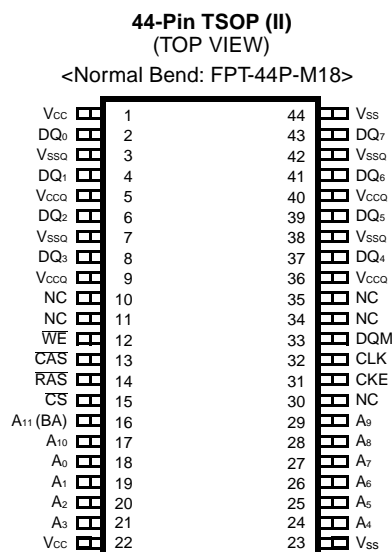44-pin plastic TSOP (II)

Marking side
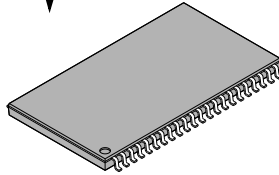
(FPT-44P-M18)
(Normal Bend)

Package and Ordering Information

– 44-pin plastic (400 mil) TSOP-II with normal bend leads,order as MB81F16822D-×××LFN
 (Low power version)

MB81F16822D-102L/-103L/-10L
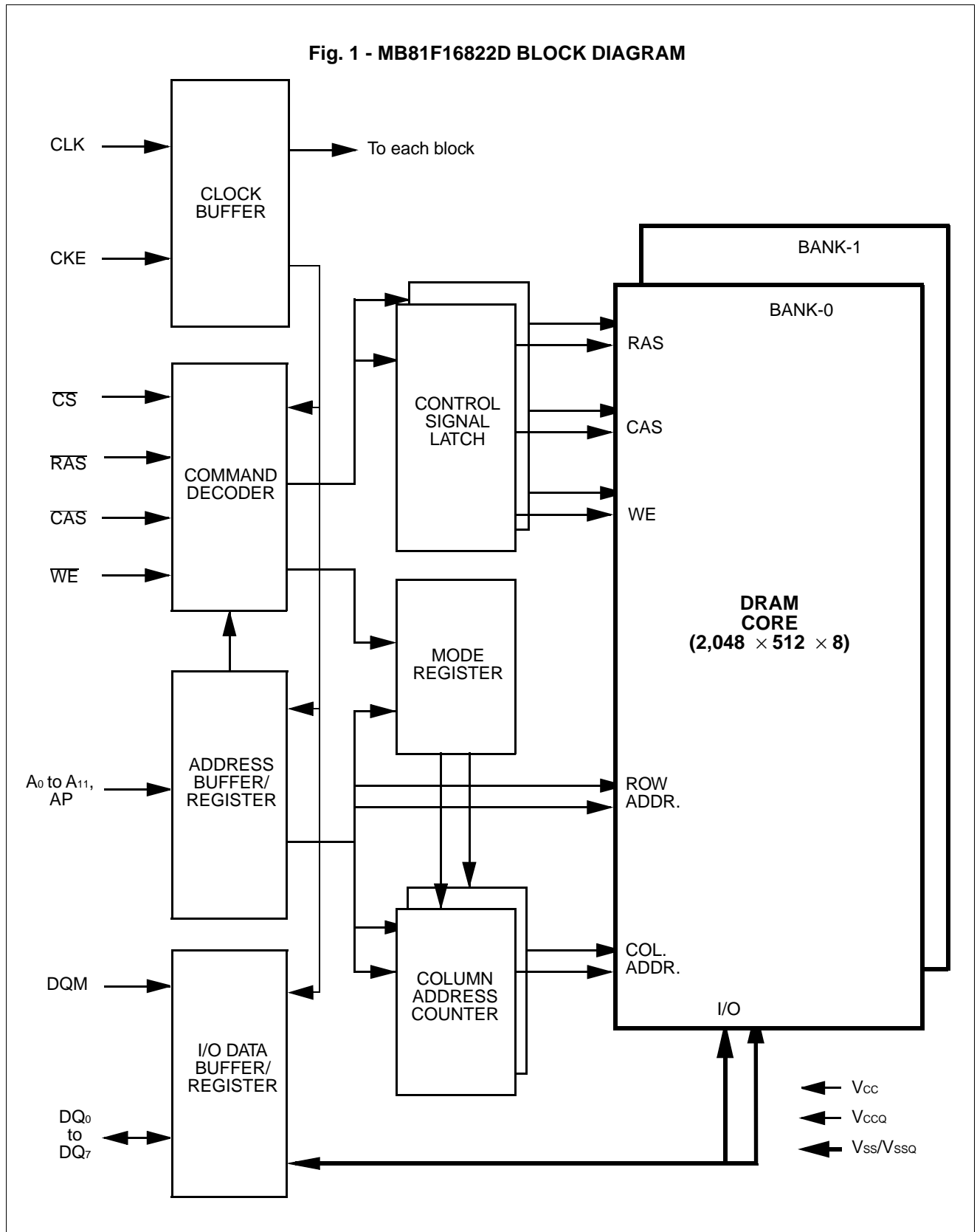
■ PIN ASSIGNMENTS AND DESCRIPTIONS

44-Pin TSOP (II)
(TOP VIEW)
<Normal Bend: FPT-44P-M18>

V_{CC}	1		44	V_{SS}
DQ_0	2		43	DQ_7
V_{SSQ}	3		42	V_{SSQ}
DQ_1	4		41	DQ_6
V_{CCQ}	5		40	V_{CCQ}
DQ_2	6		39	DQ_5
V_{SSQ}	7		38	V_{SSQ}
DQ_3	8		37	DQ_4
V_{CCQ}	9		36	V_{CCQ}
NC	10		35	NC
NC	11		34	NC
$\overline{WE}$	12		33	DQM
$\overline{CAS}$	13		32	CLK
$\overline{RAS}$	14		31	CKE
$\overline{CS}$	15		30	NC
A_{11} (BA)	16		29	A_9
A_{10}	17		28	A_8
A_0	18		27	A_7
A_1	19		26	A_6
A_2	20		25	A_5
A_3	21		24	A_4
V_{CC}	22		23	V_{SS}

(Marking side)

Pin Number	Symbol	Description	
1, 5, 9, 22, 36, 40	V_{CC}, V_{CCQ}	Supply Voltage	
2, 4, 6, 8, 37, 39, 41, 43	DQ_0 to DQ_7	Data I/O	
3, 7, 23, 38, 42, 44	V_{SS}, V_{SSQ}*	Ground	
12	$\overline{WE}$	Write Enable	
13	$\overline{CAS}$	Column Address Strobe	
14	$\overline{RAS}$	Row Address Strobe	
15	$\overline{CS}$	Chip Select	
16	A_{11} (BA)	Bank Select	
17, 18, 19, 20, 21, 24, 25, 26, 27, 28, 29	A_0 to A_{10}	Address Input	• Row : A_0 to A_{10} • Column : A_0 to A_8
10, 11, 30, 34, 35	NC	Non Connection	
31	CKE	Clock Enable	
32	CLK	Clock Input	
33	DQM	Input Mask/Output Enable	

* : These pins are connected internally in the chip.

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■ **BLOCK DIAGRAM**

Fig. 1 - MB81F16822D BLOCK DIAGRAM

CLK →

CLOCK BUFFER → To each block

CKE →

BANK-1

BANK-0

$\overline{CS}$ →

$\overline{RAS}$ →

COMMAND DECODER

$\overline{CAS}$ →

$\overline{WE}$ →

CONTROL SIGNAL LATCH → RAS

→ CAS

→ WE

MODE REGISTER

DRAM CORE (2,048 × 512 × 8)

A_0 to A_{11}, AP →

ADDRESS BUFFER/ REGISTER

ROW ADDR.

DQM →

COLUMN ADDRESS COUNTER

COL. ADDR.

I/O

I/O DATA BUFFER/ REGISTER

DQ_0 to DQ_7

V_{CC} ←

V_{CCQ} ←

V_{SS}/V_{SSQ} ←

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■ FUNCTIONAL TRUTH TABLE (Note 1)

COMMAND TRUTH TABLE Notes 2,3,4

Function	Notes	Symbol	CKE		$\overline{CS}$	$\overline{RAS}$	$\overline{CAS}$	$\overline{WE}$	A_{11} (BA)	A_{10} (AP)	A_9	A_8 to A_0
			n-1	n								
Device Deselect	*5	DESL	H	X	H	X	X	X	X	X	X	X
No Operation	*5	NOP	H	X	L	H	H	H	X	X	X	X
Burst Stop		BST	H	X	L	H	H	L	X	X	X	X
Read	*6	READ	H	X	L	H	L	H	V	L	X	V
Read with Auto-precharge	*6	READA	H	X	L	H	L	H	V	H	X	V
Write	*6	WRIT	H	X	L	H	L	L	V	L	X	V
Write with Auto-precharge	*6	WRITA	H	X	L	H	L	L	V	H	X	V
Bank Active ($\overline{RAS}$)	*7	ACTV	H	X	L	L	H	H	V	V	V	V
Precharge Single Bank		PRE	H	X	L	L	H	L	V	L	X	X
Precharge All Banks		PALL	H	X	L	L	H	L	X	H	X	X
Mode Register Set	*8,9	MRS	H	X	L	L	L	L	L	L	V	V

Notes: *1.   V = Valid, L = Logic Low, H = Logic High, X = either L or H.
   *2.   All commands assume no CSUS command on previous rising edge of clock.
   *3.   All commands are assumed to be valid state transitions.
   *4.   All inputs are latched on the rising edge of clock.
   *5.   NOP and DESL commands have the same effect on the part.
   *6.   READ, READA, WRIT, and WRITA commands should only be issued after the corresponding bank has been activated (ACTV command). Refer to STATE DIAGRAM.
   *7.   ACTV command should only be asserted after corresponding bank has been precharged (PRE or PALL command).
   *8.   Required after power up.
   *9.   MRS command should only be issued after all banks have been precharged (PRE or PALL command). Refer to STATE DIAGRAM.

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DQM TRUTH TABLE

Function	Command	CKE		DQM
		n-1	n	
Data Write/Output Enable	ENBL	H	X	L
Data Mask/Output Disable	MASK	H	X	H

CKE TRUTH TABLE

Current State	Function Notes	Symbol	CKE		$\overline{CS}$	$\overline{RAS}$	$\overline{CAS}$	$\overline{WE}$	A11 (BA)	A10 (AP)	A9 to A0
			n-1	n							
Bank Active	Clock Suspend Mode Entry *1,*5	CSUS	H	L	X	X	X	X	X	X	X
Any Except to Idle	Clock Suspend Continue *1		L	L	X	X	X	X	X	X	X
Clock Suspend	Clock Suspend Mode Exit		L	H	X	X	X	X	X	X	X
Idle	Auto-refresh Command *2,*4	REF	H	H	L	L	L	H	X	X	X
Idle	Self-refresh Entry *2,*3	SELF	H	L	L	L	L	H	X	X	X
Self-refresh	Self-refresh Exit	SELFX	L	H	L	H	H	H	X	X	X
			L	H	H	X	X	X	X	X	X
Idle	Power Down Entry *3	PD	H	L	L	H	H	H	X	X	X
			H	L	H	X	X	X	X	X	X
Power Down	Power Down Exit		L	H	L	H	H	H	X	X	X
			L	H	H	X	X	X	X	X	X

Notes: *1.   The CSUS command requires that at least one bank is active. Refer to STATE DIAGRAM.
　　　　*2.   REF and SELF commands should only be issued after all banks have been precharged (PRE or PAL command). Refer to STATE DIAGRAM.
　　　　*3.   Self and PD commands should only be issued after the last data have been appeared on DQ.
　　　　*4.   Once it enters the auto-refresh mode, Asynchronous Self-Refresh Entry exceuted when CKE is brought Low together with DESL or NOP command(ASE command) within t_{ASE}.
　　　　*5.   NOP or DESL commands should only be issued after CSUS and PRE(or PALL) commands asserted at same time.

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OPERATION COMMAND TABLE (Applicable to single bank)

Current State	$\overline{CS}$	$\overline{RAS}$	$\overline{CAS}$	$\overline{WE}$	Addr	Command	Function	Notes
Idle	H	X	X	X	X	DESL	NOP	
	L	H	H	H	X	NOP	NOP	
	L	H	H	L	X	BST	NOP	
	L	H	L	H	BA, CA, AP	READ/READA	Illegal	*2
	L	H	L	L	BA, CA, AP	WRIT/WRITA	Illegal	*2
	L	L	H	H	BA, RA	ACTV	Bank Active after t_{RCD}	
	L	L	H	L	BA, AP	PRE/PALL	NOP	*6
	L	L	L	H	X	REF/SELF	Auto-refresh or Self-refresh	*3
	L	L	L	L	MODE	MRS	Mode Register Set (Idle after t_{RSC})	*3,*7
Bank Active	H	X	X	X	X	DESL	NOP	
	L	H	H	H	X	NOP	NOP	
	L	H	H	L	X	BST	NOP	
	L	H	L	H	BA, CA, AP	READ/READA	Begin Read; Determine AP	
	L	H	L	L	BA, CA, AP	WRIT/WRITA	Begin Write; Determine AP	
	L	L	H	H	BA, RA	ACTV	Illegal	*2
	L	L	H	L	BA, AP	PRE/PALL	Precharge; Determine Precharge Type	
	L	L	L	H	X	REF/SELF	Illegal	
	L	L	L	L	MODE	MRS	Illegal	

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Current State	C̄S̄	R̄Ā̄S̄	C̄Ā̄S̄	W̄Ē	Addr	Command	Function	Notes
Read	H	X	X	X	X	DESL	NOP (Continue Burst to End → Bank Active)	
	L	H	H	H	X	NOP	NOP (Continue Burst to End → Bank Active)	
	L	H	H	L	X	BST	Burst Stop → Bank Active	
	L	H	L	H	BA, CA, AP	READ/READA	Terminate Burst, New Read; Determine AP	
	L	H	L	L	BA, CA, AP	WRIT/WRITA	Terminate Burst, Start Write; Determine AP	*4
	L	L	H	H	BA, RA	ACTV	Illegal	*2
	L	L	H	L	BA, AP	PRE/PALL	Terminate Burst, Precharge; → Idle Determine Precharge Type	
	L	L	L	H	X	REF/SELF	Illegal	
	L	L	L	L	MODE	MRS	Illegal	
Write	H	X	X	X	X	DESL	NOP (Continue Burst to End → Bank Active)	
	L	H	H	H	X	NOP	NOP (Continue Burst to End → Bank Active)	
	L	H	H	L	X	BST	Burst Stop → Bank Active	
	L	H	L	H	BA, CA, AP	READ/READA	Terminate Burst, Start Read; Determine AP	
	L	H	L	L	BA, CA, AP	WRIT/WRITA	Terminate Burst, New Write; Determine AP	
	L	L	H	H	BA, RA	ACTV	Illegal	*2
	L	L	H	L	BA, AP	PRE/PALL	Terminate Burst, Precharge; Determine Precharge Type	
	L	L	L	H	X	REF/SELF	Illegal	
	L	L	L	L	MODE	MRS	Illegal	

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Current State	$\overline{CS}$	$\overline{RAS}$	$\overline{CAS}$	$\overline{WE}$	Addr	Command	Function	Notes
Read with Auto-precharge	H	X	X	X	X	DESL	NOP (Continue Burst to End → Precharge → Idle)	
	L	H	H	H	X	NOP	NOP (Continue Burst to End → Precharge → Idle)	
	L	H	H	L	X	BST	Illegal	
	L	H	L	H	BA, CA, AP	READ/READA	Illegal	*2
	L	H	L	L	BA, CA, AP	WRIT/WRITA	Illegal	*2
	L	L	H	H	BA, RA	ACTV	Illegal	*2
	L	L	H	L	BA, AP	PRE/PALL	Illegal	*2
	L	L	L	H	X	REF/SELF	Illegal	
	L	L	L	L	MODE	MRS	Illegal	
Write with Auto-precharge	H	X	X	X	X	DESL	NOP (Continue Burst to End → Precharge → Idle)	
	L	H	H	H	X	NOP	NOP (Continue Burst to End → Precharge → Idle)	
	L	H	H	L	X	BST	Illegal	
	L	H	L	H	BA, CA, AP	READ/READA	Illegal	*2
	L	H	L	L	BA, CA, AP	WRIT/WRITA	Illegal	*2
	L	L	H	H	BA, RA	ACTV	Illegal	*2
	L	L	H	L	BA, AP	PRE/PALL	Illegal	*2
	L	L	L	H	X	REF/SELF	Illegal	
	L	L	L	L	MODE	MRS	Illegal	

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Current State	$\overline{CS}$	$\overline{RAS}$	$\overline{CAS}$	$\overline{WE}$	Addr	Command	Function	Notes
Precharge	H	X	X	X	X	DESL	NOP (Idle after t_{RP})	
	L	H	H	H	X	NOP	NOP (Idle after t_{RP})	
	L	H	H	L	X	BST	Illegal	
	L	H	L	H	BA, CA, AP	READ/READA	Illegal	*2
	L	H	L	L	BA, CA, AP	WRIT/WRITA	Illegal	*2
	L	L	H	H	BA, RA	ACTV	Illegal	*2
	L	L	H	L	BA, AP	PRE/PALL	NOP (PALL may effect other bank)	*5
	L	L	L	H	X	REF/SELF	Illegal	
	L	L	L	L	MODE	MRS	Illegal	
Bank Activating	H	X	X	X	X	DESL	NOP (Bank Active after t_{RCD})	
	L	H	H	H	X	NOP	NOP (Bank Active after t_{RCD})	
	L	H	H	L	X	BST	NOP (Bank Active after t_{RCD})	
	L	H	L	H	BA, CA, AP	READ/READA	Illegal	*2
	L	H	L	L	BA, CA, AP	WRIT/WRITA	Illegal	*2
	L	L	H	H	BA, RA	ACTV	Illegal	*2
	L	L	H	L	BA, AP	PRE/PALL	Illegal	*2
	L	L	L	H	X	REF/SELF	Illegal	
	L	L	L	L	MODE	MRS	Illegal	

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Current State	$\overline{CS}$	$\overline{RAS}$	$\overline{CAS}$	$\overline{WE}$	Addr	Command	Function	Notes
Refreshing	H	X	X	X	X	DESL	NOP (Idle after t_{RC})	*8
	L	H	H	X	X	NOP/BST	NOP (Idle after t_{RC})	*8
	L	H	L	X	X	READ/READA/WRIT/WRITA	Illegal	
	L	L	H	X	X	ACTV/PRE/PALL	Illegal	
	L	L	L	X	X	REF/SELF/MRS	Illegal	
Mode Register Setting	H	X	X	X	X	DESL	NOP (Idle after t_{RSC})	
	L	H	H	H	X	NOP	NOP (Idle after t_{RSC})	
	L	H	H	L	X	BST	Illegal	
	L	H	L	X	X	READ/READA/WRIT/WRITA	Illegal	
	L	L	X	X	X	ACTV/PRE/PALL/REF/SELF/MRS	Illegal	

ABBREVIATIONS:
    RA = Row Address   BA = Bank Address
    CA = Column Address   AP = Auto Precharge

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COMMAND TRUTH TABLE FOR CKE

Current State	CKE n-1	CKE n	$\overline{CS}$	$\overline{RAS}$	$\overline{CAS}$	$\overline{WE}$	Addr	Function	Notes
Self-refresh	H	X	X	X	X	X	X	Invalid	
	L	H	H	X	X	X	X	Exit Self-refresh (Self-refresh Recovery $\rightarrow$ Idle after t_{RC})	
	L	H	L	H	H	H	X	Exit Self-refresh (Self-refresh Recovery $\rightarrow$ Idle after t_{RC})	
	L	H	L	H	H	L		Illegal	
	L	H	L	H	L	X	X	Illegal	
	L	H	L	L	X	X	X	Illegal	
	L	L	X	X	X	X	X	NOP (Maintain Self-refresh)	
Self-refresh Recovery	L	X	X	X	X	X	X	Invalid	
	H	H	H	X	X	X	X	Idle after t_{RC}	
	H	H	L	H	H	H	X	Idle after t_{RC}	
	H	H	L	H	H	L	X	Illegal	
	H	H	L	H	L	X	X	Illegal	
	H	H	L	L	X	X	X	Illegal	
	H	H	X	X	X	X	X	Illegal	
	H	L	X	X	X	X	X	Illegal	

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Current State	CKE n-1	CKE n	$\overline{CS}$	$\overline{RAS}$	$\overline{CAS}$	$\overline{WE}$	Addr	Function	Notes
Power Down	H	X	X	X	X	X		Invalid	
	L	H	H	X	X	X	X	Exit Power Down Mode → Idle	
	L	H	L	H	H	H	X	Exit Power Down Mode → Idle	
	L	L	X	X	X	X	X	NOP (Maintain Power Down Mode)	
	L	H	L	L	X	X	X	Illegal	
	L	H	L	H	L	X	X	Illegal	
Both Banks Idle	H	H	H	X	X	X		Refer to the Operation Command Table.	
	H	H	L	H	X	X		Refer to the Operation Command Table.	
	H	H	L	L	H	X		Refer to the Operation Command Table.	
	H	H	L	L	L	H	X	Auto-refresh	
	H	H	L	L	L	L	MODE	Refer to the Operation Command Table.	
	H	L	H	X	X	X	X	Power Down	
	H	L	L	H	H	H	X	Power Down	
	H	L	L	H	H	L	X	Illegal	
	H	L	L	H	L	X		Illegal	
	H	L	L	L	H	X		Illegal	
	H	L	L	L	L	H	X	Self-refresh	
	H	L	L	L	L	L	MODE	Illegal	
	L	X	X	X	X	X	X	Invalid	

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Current State	CKE n-1	CKE n	$\overline{CS}$	$\overline{RAS}$	$\overline{CAS}$	$\overline{WE}$	Addr	Function	Notes
Bank Active Bank Activating Read/Write	H	H	X	X	X	X	X	Refer to the Operation Command Table	
	H	L	X	X	X	X	X	Begin Clock Suspend Next Cycle	
	L	X	X	X	X	X	X	Invalid	
Clock Suspend	H	X	X	X	X	X	X	Invalid	
	L	H	X	X	X	X	X	Exit Clock Suspend Next Cycle	
	L	L	X	X	X	X	X	Maintain Clock Suspend	
Any State Other Than Listed Above	H	H	X	X	X	X	X	Refer to the Operation Command Table	
	H	L	X	X	X	X	X	Illegal	
	L	X	X	X	X	X	X	Invalid	

Notes: *1. All entries assume the CKE was High during the proceeding clock cycle and the current clock cycle. Illegal means don't used command. If used, power up sequence be asserted after power shut down.
*2. Illegal to bank in specified state; entry may be legal in the bank specified by BA, depending on the state of that bank.
*3. Illegal if any bank is not idle.
*4. Must satisfy bus contention, bus turn around, and/or write recovery requirements.
*5. NOP to bank precharging or in idle state. May precharge bank specified by BA (and AP).
*6. SELF command should only be issued after the last read data have been appeared on DQ.
*7. MRS command should only be issued on condition that all DQ are in Hi-Z.
*8. Asynchronous Self-refresh Entry executed when CKE is brought Low together with DSEL or NOP command(ASE command) within t_{ASE}.

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■ FUNCTIONAL DESCRIPTION

SDRAM BASIC FUNCTION

Three major differences between this SDRAM and conventional DRAMs are: synchronized operation, burst mode, and mode register.

The **synchronized operation** is the fundamental difference. An SDRAM uses a clock input for the synchronization, where the DRAM is basically asynchronous memory although it has been using two clocks, $\overline{RAS}$ and $\overline{CAS}$. Each operation of DRAM is determined by their timing phase differences while each operation of SDRAM is determined by commands and all operations are referenced to a positive clock edge. Fig.2 shows the basic timing diagram differences between SDRAMs and DRAMs.

The **burst mode** is a very high speed access mode utilizing an internal column address generator. Once a column addresses for the first access is set, following addresses are automatically generated by the internal column address counter.

The **mode register** is to justify the SDRAM operation and function into desired system conditions. MODE REGISTER TABLE shows how SDRAM can be configured for system requirement by mode register programming.

CLOCK (CLK) AND CLOCK ENABLE (CKE)

All input and output signals of SDRAM use register type buffers. A CLK is used as a trigger for the register and internal burst counter increment. All inputs are latched by a positive edge of CLK. All outputs are validated by the CLK. CKE is a high active clock enable signal. When CKE = Low is latched at a clock input during active cycle, the next clock will be internally masked. During idle state (all banks have been precharged), the Power Down mode(standby) is entered with CKE = Low and this will make extremely low standby current.

CHIP SELECT ($\overline{CS}$)

$\overline{CS}$ enables all commands inputs, $\overline{RAS}$, $\overline{CAS}$, and $\overline{WE}$, and address input. When $\overline{CS}$ is High , command signals are negated but internal operation such as burst cycle will not be suspended. If such a control isn't needed, $\overline{CS}$ can be tied to ground level.

COMMAND INPUTS ($\overline{RAS}$, $\overline{CAS}$ AND $\overline{WE}$)

Unlike a conventional DRAM, $\overline{RAS}$, $\overline{CAS}$, and $\overline{WE}$ do not directly imply SDRAM operation, such as Row address strobe by $\overline{RAS}$. Instead, each combination of $\overline{RAS}$, $\overline{CAS}$, and $\overline{WE}$ input in conjunction with $\overline{CS}$ input at a rising edge of the CLK determines SDRAM operation. Refer to FUNCTIONAL TRUTH TABLE in page 5.

ADDRESS INPUTS (A_0 to A_{10})

Address input selects an arbitrary location of a total of 1,048,576 words of each memory cell matrix. A total of twenty address input signals are required to decode such a matrix. SDRAM adopts an address multiplexer in order to reduce the pin count of the address line. At a Bank Active command (ACTV), eleven Row addresses are initially latched and the remainder of nine Column addresses are then latched by a Column address strobe command of either a Read command (READ or READA) or Write command (WRIT or WRITA).

BANK SELECT (A_{11})

This SDRAM has two banks and each bank is organized as 1 M words by 8-bit.
Bank selection by A_{11} occurs at Bank Active command (ACTV) followed by read (READ or READA), write (WRIT or WRITA), and precharge command (PRE).

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DATA INPUTS AND OUTPUTS (DQ$_0$ to DQ$_7$)

Input data is latched and written into the memory at the clock following the write command input. Data output is obtained by the following conditions followed by a read command input:

t_{RAC} : from the bank active command when t_{RCD} (min) is satisfied. (This parameter is reference only.)
t_{CAC} : from the read command when t_{RCD} is greater than t_{RCD} (min).(This parameter is reference only.)
t_{AC} : from the clock edge after t_{RAC} and t_{CAC}.

The polarity of the output data is identical to that of the input. Data is valid between access time (determined by the three conditions above) and the next positive clock edge (t_{OH}).

DATA I/O MASK (DQM)

DQM is active high enable inputs and have an output disable and input mask function. During burst cycle and when DQM = High is latched by a clock, input is masked at the same clock and output will be masked at the second clock later while internal burst counter will increment by one or will go to the next stage depending on burst type.

BURST MODE OPERATION AND BURST TYPE

The burst mode provides faster memory access. The burst mode is implemented by keeping the same Row address and by automatic strobing column address. Access time and cycle time of Burst mode is specified as t_{AC} and t_{CK}, respectively. The internal column address counter operation is determined by a mode register which defines burst type and burst count length of 1,2,4 or 8 bits of boundary. In order to terminate or to move from the current burst mode to the next stage while the remaining burst count is more than 1, the following combinations will be required:

Current Stage	Next Stage	Method (Assert the following command)	
Burst Read	Burst Read	Read Command	
Burst Read	Burst Write	1st Step	Mask Command (Normally 3 clock cycles)
		2nd Step	Write Command after I_{OWD}
Burst Write	Burst Write	Write Command	
Burst Write	Burst Read	Read Command	
Burst Read	Precharge	Precharge Command	
Burst Write	Precharge	Precharge Command	

The burst type can be selected either sequential or interleave mode if burst length is 2,4 or 8. The sequential mode is an incremental decoding scheme within a boundary address to be determined by count length, it assigns +1 to the previous (or initial) address until reaching the end of boundary address and then wraps round to least significant address(=0). The interleave mode is a scrambled decoding scheme for A$_0$ and A$_2$. If the first access of column address is even (0), the next address will be odd (1), or vice-versa.

(Continued)

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(Continued)

When the full burst operation is executed at single write mode, Auto-precharge command is valid only at write operation.

The burst type can be selected either sequential or interleave mode. But only the sequential mode is usable to the full column burst. The sequential mode is an incremental decoding scheme within a boundary address to be determined by burst length, it assigns +1 to the previous (or initial) address until reaching the end of boundary address and then wraps round to least significant address(=0).

Burst Length	Stating Column Address A_2 A_1 A_0	Sequential Mode	Interleave
2	X X 0	0 - 1	0 - 1
2	X X 1	1 - 0	1 - 0
4	X 0 0	0 - 1 - 2 - 3	0 - 1 - 2 - 3
4	X 0 1	1 - 2 - 3 - 0	1 - 0 - 3 - 2
4	X 1 0	2 - 3 - 0 - 1	2 - 3 - 0 - 1
4	X 1 1	3 - 0 - 1 - 2	3 - 2 - 1 - 0
8	0 0 0	0 - 1 - 2 - 3 - 4 - 5 - 6 - 7	0 - 1 - 2 - 3 - 4 - 5 - 6 - 7
8	0 0 1	1 - 2 - 3 - 4 - 5 - 6 - 7 - 0	1 - 0 - 3 - 2 - 5 - 4 - 7 - 6
8	0 1 0	2 - 3 - 4 - 5 - 6 - 7 - 0 - 1	2 - 3 - 0 - 1 - 6 - 7 - 4 - 5
8	0 1 1	3 - 4 - 5 - 6 - 7 - 0 - 1 - 2	3 - 2 - 1 - 0 - 7 - 6 - 5 - 4
8	1 0 0	4 - 5 - 6 - 7 - 0 - 1 - 2 - 3	4 - 5 - 6 - 7 - 0 - 1 - 2 - 3
8	1 0 1	5 - 6 - 7 - 0 - 1 - 2 - 3 - 4	5 - 4 - 7 - 6 - 1 - 0 - 3 - 2
8	1 1 0	6 - 7 - 0 - 1 - 2 - 3 - 4 - 5	6 - 7 - 4 - 5 - 2 - 3 - 0 - 1
8	1 1 1	7 - 0 - 1 - 2 - 3 - 4 - 5 - 6	7 - 6 - 5 - 4 - 3 - 2 - 1 - 0

FULL COLUMN BURST AND BURST STOP COMMAND (BST)

The full column burst is an option of burst length and available only at sequential mode of burst type. This full column burst mode is repeatedly access to the same column. If burst mode reaches end of column address, then it wraps round to first column address (=0) and continues to count until interrupted by the news Read (READ) /Write (WRIT) , Precharge (PRE) , or Burst Stop (BST) command. The selection of Auto-precharge option is illegal during the full column burst operation except write command at BURST READ & SINGLE WRITE mode.

The BST command is applicable to terminated burst operation. If the BST command is asserted burst mode, its operation is terminated immediately and the internal state moves to Bank Active.

When read mode is interrupted by BST command, the output will be in High-Z.
For the detail rule, please refer to TIMING DIAGRAM-8.
When write mode is interrupted by BST command, the data to be applied at the same time with BST command will be ignored.

BURST READ & SINGLE WRITE

The burst read and single write mode provides single word write operation regardless of its burst length. In this mode, burst read operation does not affected by this mode.

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PRECHARGE AND PRECHARGE OPTION (PRE, PALL)

SDRAM memory core is the same as conventional DRAMs', requiring precharge and refresh operations. Precharge rewrites the bit line and to reset the internal Row address line and is executed by the Precharge command (PRE). With the Precharge command, SDRAM will automatically be in standby state after precharge time (t_{RP}).

The precharged bank is selected by combination of AP and A_{11} when Precharge command is asserted. If AP = High, both banks are precharged regardless of A_{11} (PALL). If AP = Low, a bank to be selected by A_{11} is precharged (PRE). The Auto-precharge enters precharge mode at the end of burst mode of read or write without Precharge command assertion. This Auto-precharge is entered by AP = High when a read or write command is asserted. Refer to FUNCTION TRUTH TABLE.

AUTO-REFRESH (REF)

Auto-refresh uses the internal refresh address counter. The SDRAM Auto-refresh command (REF) generates Precharge command internally. All banks of SDRAM should be precharged prior to the Auto-refresh command. The Auto-refresh command should also be asserted every 15.6 μs or a total 4096 refresh commands within a 64 ms period.

SELF-REFRESH ENTRY (SELF)

Self-refresh function provides automatic refresh by an internal timer as well as Auto-refresh and will continue the refresh function until cancelled by SELFX.

The Self-refresh is entered by applying an Auto-refresh command in conjunction with CKE = Low (SELF). Once SDRAM enters the self-refresh mode, all inputs except for CKE will be "don't care" (either logic high or low level state) and outputs will be in a High-Z state. During a Self-refresh mode, CKE = Low should be maintained. SELF command should only be issued after last read data has been appeared on DQ.

ASYNCHRONOUS SELF-REFRESH ENTRY(ASE)

The SELF command requires high speed control to the CKE as well as other command inputs. The MB81F16822D supports Asynchronous Self-refresh entry and it executed when CKE is brought Low together with DESL or NOP command(ASE command) within t_{ASE}(min). Once it enters the self-refresh mode, CKE=Low should be maintained as the same manner as regular Self-refresh mode. ASE command should only be effective if not of access command is issued after the last REF command has been issued.

SELF-REFRESH EXIT (SELFX)

To Exit SElf-Refresh mode, apply minimum t_{CKSP} before CKE brought high, and then the NOP command (NOP) or the Deselect command (DESL) should be asserted within minimum tRC. Refer to Timing Diagram for the detail.It is recommended to assert an Auto-refresh command just after the t_{RC} period to avoid the violation of refresh period.

MODE REGISTER SET (MRS)

The mode register of SDRAM provides a variety of different operations. The register consists of four operation fields; Burst Length, Burst Type, CAS latency, and Operation Code. Refer to MODE REGISTER TABLE in page 33.

The mode register can be programmed by the Mode Register Set command (MRS). Each field is set by the address line. Once a mode register is programmed, the contents of the register will be held until re-programmed by another MRS command (or part loses power). MRS command should only be issued on condition that all DQ is in Hi-Z.

The condition of the mode register is undefined after the power-up stage. It is required to set each field after initialization of SDRAM. Refer to POWER-UP INITIALIZATION below.

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POWER-UP INITIALIZATION

The SDRAM internal condition after power-up will be undefined. It is required to follow the following Power On Sequence to execute read or write operation.
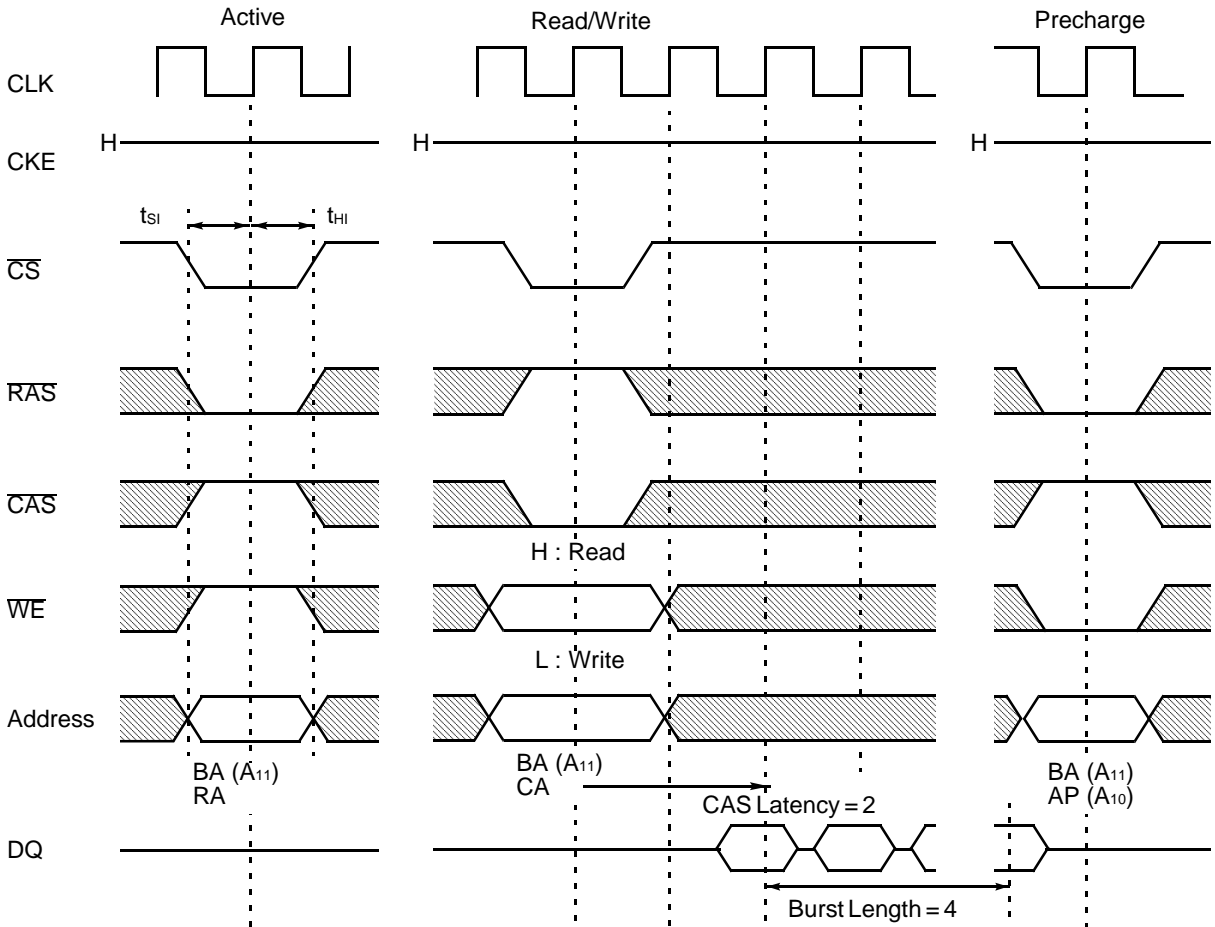
1. Apply power and start clock. Attempt to maintain either NOP or DESL command at the input.
2. Maintain stable power, stable clock, and NOP condition for a minimum of 200 μs.
3. Precharge all banks by Precharge (PRE) or Precharge All command (PALL).
4. Assert minimum of 8 Auto-refresh command(REF).
5. Program the mode register by Mode Register Set command(MRS).

In addition, it is recommended DQM and CKE to track V_{CC} to insure that output is High-Z state. The Mode Register Set command (MRS) can be set before 8 Auto-refresh command (REF).

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Fig. 2 – BASIC TIMING FOR CONVENTIONAL DRAM vs. SYNCHRONOUS DYNAMIC RAM

<SDRAM>

| Active | Read/Write | Precharge |

CLK

CKE   H   H   H

t_{SI} t_{HI}

$\overline{CS}$

$\overline{RAS}$

$\overline{CAS}$

H : Read

$\overline{WE}$

L : Write

Address

BA (A_{11})   BA (A_{11})   BA (A_{11})
RA   CA   AP (A_{10})

CAS Latency = 2

DQ

Burst Length = 4

<Conventional DRAM>

Row Address Select   Precharge

$\overline{RAS}$ Column Address Select

$\overline{CAS}$

DQ

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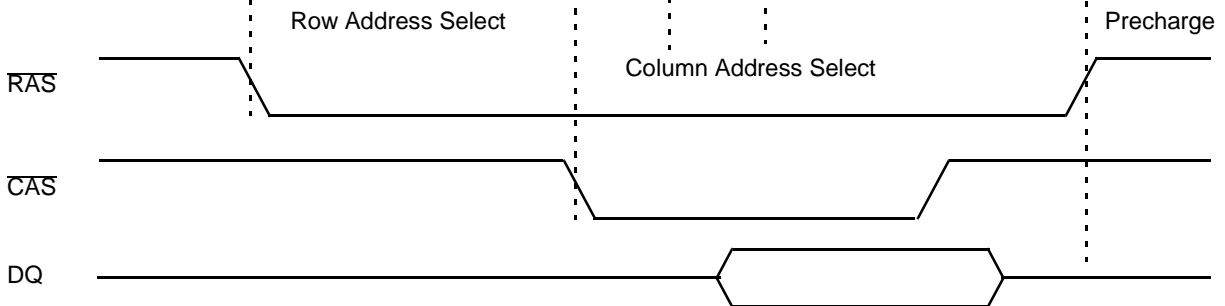
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MINIMUM CLOCK LATENCY OR DELAY TIME FOR 1 BANK OPERATION

First command \ Second command (same bank)	MRS	ACTV	READ	READA	WRT	WRITA	PRE	PALL	REF	SELF
MRS	t_{RSC}	t_{RSC}					t_{RSC}	t_{RSC}	t_{RSC}	t_{RSC}
ACTV			t_{RCD}	t_{RCD} *4	t_{RCD}	t_{RCD} *4	t_{RAS}	t_{RAS}		
READ			1	1	1 *1	1 *1	1	1		
READA	BL + t_{RP} *2	BL + t_{RP} *2							BL + t_{RP} *2	BL + t_{RP} *2
WRIT			t_{WR}	t_{WR}	1	1	t_{DPL}	t_{DPL}		
WRITA	t_{DAL}	t_{DAL}							t_{DAL}	t_{DAL}
PRE	t_{RP} *3	t_{RP} *3					t_{RP}	t_{RP}	t_{RP} *3	t_{RP} *3
PALL	t_{RP} *3	t_{RP} *3					t_{RP}	t_{RP}	t_{RP} *3	t_{RP} *3
REF	t_{RC}	t_{RC}					t_{RC}	t_{RC}	t_{RC}	t_{RC}
SELFX	t_{RC}	t_{RC}							t_{RC}	t_{RC}

Notes:
*1. Assume no I/O conflict.
*2. If $t_{RP} \leq t_{CK}$, minimum latency is a sum of BL + CL.
*3. Assume Output is in High-Z state.
*4. Assume t_{RAS} is satisfied.

Illegal Command

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MINIMUM CLOCK LATENCY OR DELAY TIME FOR 2 BANK OPERATION

First command \ Second command (opposite bank)	MRS	ACTV	READ	READA	WRT	WRITA	PRE	PALL	REF	SELF
MRS	t_{RSC}	t_{RSC}					t_{RSC}	t_{RSC}	t_{RSC}	t_{RSC}
ACTV		t_{RRD} [*1]	1 [*2]	1 [*2]	1 [*2]	1 [*2]	1 [*7]	t_{RAS}		
READ		1 [*1]	1 [*2]	1 [*2]	1 [*2,*3]	1 [*2,*3]	1 [*7]	1 [*8]		
READA [*9]	BL + t_{RP} [*1,*4]	1 [*1]	1	1	1	1	1		BL + t_{RP} [*1,*4]	BL + t_{RP} [*1,*4]
WRIT		1 [*1]	1 [*2]	1 [*2]	1 [*2]	1 [*2]	1 [*7]	1 [*8]		
WRITA [*9]	BL + t_{RP} [*1,*4]	1 [*1]	1	1	1	1	1		BL + 1 + t_{RP} [*1]	BL + 1 + t_{RP} [*1]
PRE	t_{RP} [*1]	1 [*1]	1 [*2]	1 [*2]	1 [*2]	1 [*2]	1	t_{RAS}	t_{RP} [*1]	t_{RP} [*1]
PALL	t_{RP}	t_{RP} [*1]					1	1	t_{RP} [*1,*6]	t_{RP} [*1,*6]
REF	t_{RC}	t_{RC}					t_{RC}	t_{RC}	t_{RC}	t_{RC}
SELFX	t_{RC}	t_{RC}							t_{RC}	t_{RC}

Notes:
- *1. Assume opposite bank is in idle state.
- *2. Assume opposite bank is in active state.
- *3. Assume no I/O conflict.
- *4. If $t_{RP} \leq t_{CK}$, minimum latency is a sum of BL + CL.
- *5. Assume PALL command dose not affect any operation on opposite bank.
- *6. Assume Output is in High-Z state.
- *7. Assume t_{RAS} of opposite bank is satisfied.
- *8. Assume t_{RAS}(ACTV to PALL) is satisfied.
- *9. If opposite bank should be interrupted, tRAS of own bank is satisfied..

[gray box] Illegal Command

Fig. 3 – STATE DIAGRAM (Simplified for Single Bank Operation State Diagram)
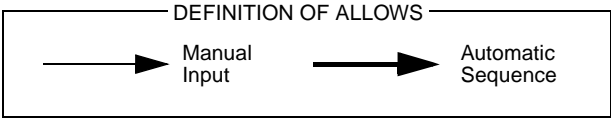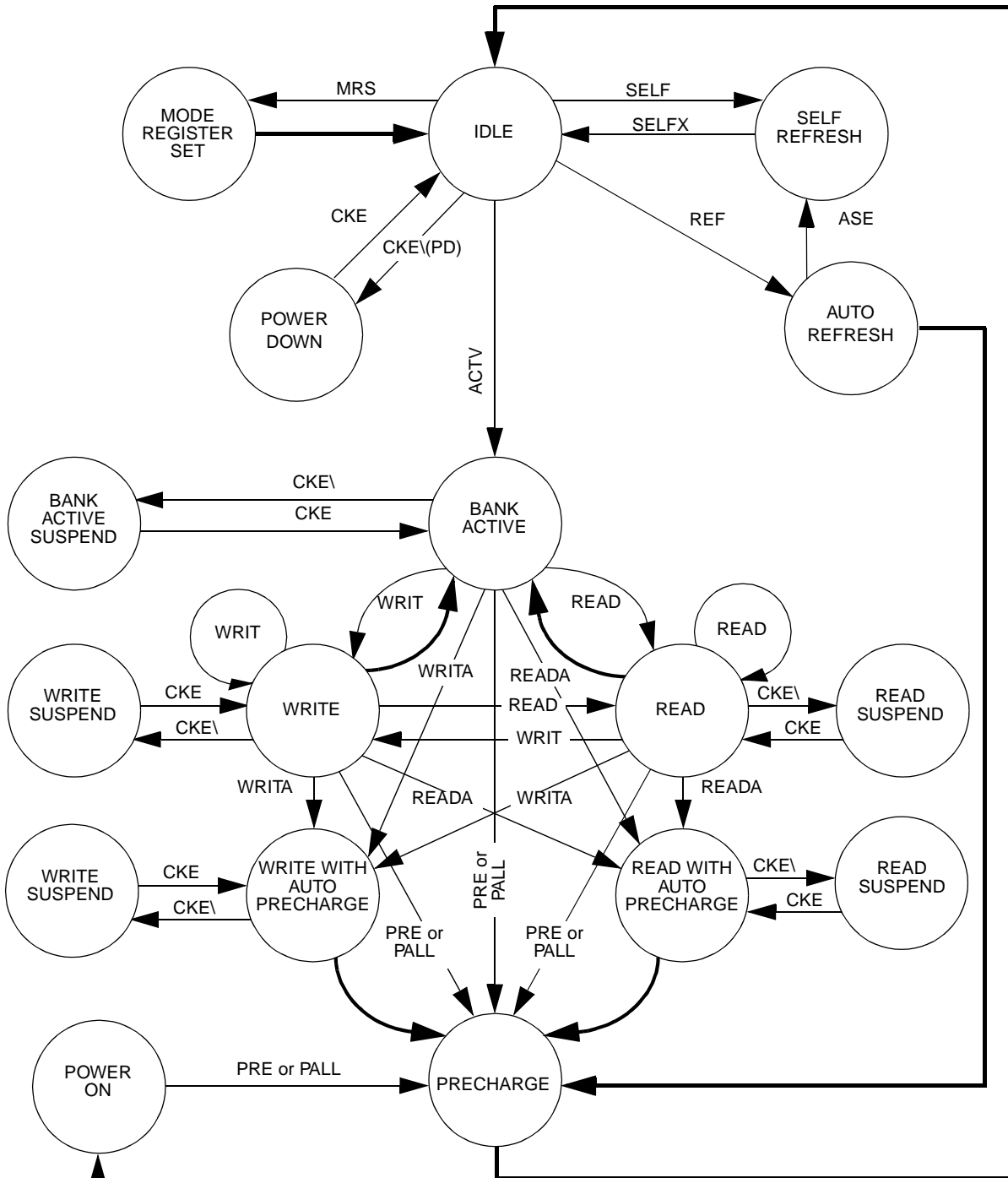
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■ ABSOLUTE MAXIMUM RATINGS (See WARNING)

Parameter	Symbol	Value	Unit
Voltage of V_{CC} Supply Relative to V_{SS}	V_{CC}	−0.5 to +4.6	V
Voltage at Any Pin Relative to V_{SS}	V_{IN}, V_{OUT}	−0.5 to +4.6	V
Short Circuit Output Current	I_{OUT}	−50 to +50	mA
Power Dissipation	P_D	1.3	W
Storage Temperature	T_{STG}	−55 to +125	°C

WARNING: Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed these ratings.

■ RECOMMENDED OPERATING CONDITIONS
(Referenced to V_{SS})

Parameter	Notes	Symbol	Min.	Typ.	Max.	Unit
Supply Voltage		V_{CC}, V_{CCQ}	3.0	3.3	3.6	V
		V_{SS}, V_{SSQ}	0	0	0	V
Input High Voltage	*1	V_{IH}	2.0	—	V_{CC} + 0.5	V
Input Low Voltage	*2	V_{IL}	−0.5	—	0.8	V
Ambient Temperature		T_A	0	—	70	°C

Notes: *1. Overshoot limit: V_{IH} (max)= V_{CC} + 1.5 V with a pulsewidth ≤ 5 ns.
　　　　 *2. Undershoot limit: V_{IL} (min)= −1.5 V with a pulsewidth ≤ 5 ns

WARNING: Recommended operating conditions are normal operating ranges for the semiconductor device. All the device's electrical characteristics are warranted when operated within these ranges.

Always use semiconductor devices within the recommended operating conditions. Operation outside these ranges may adversely affect reliability and could result in device failure.

No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their FUJITSU representative beforehand.

■ CAPACITANCE

$(T_A = 25°C, f = 1 MHz)$

Parameter	Symbol	Min.	Typ.	Max.	Unit
Input Capacitance, Except for CLK	C_{IN1}	2.5	—	5	pF
Input Capacitance for CLK	C_{IN2}	2.5	—	4	pF
I/O Capacitance	$C_{I/O}$	4.0	—	6.5	pF

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■ DC CHARACTERISTICS
(At recommended operating conditions unless otherwise noted.)   Notes 1, 2

Parameter		Symbol	Conditions	Value Min.	Value Max.	Unit
Output High Voltage		$V_{OH(DC)}$	$I_{OH} = -2\,mA$	2.4	—	V
Output Low Voltage		$V_{OL(DC)}$	$I_{OL} = 2\,mA$	—	0.4	V
Input Leakage Current (Any Input)		I_{LI}	$0\,V \le V_{IN} \le V_{CC}$; All other pins not under test = 0 V	–5	5	µA
Output Leakage Current		I_{LO}	$0\,V \le V_{IN} \le V_{CC}$; Data out disabled	–5	5	µA
Operating Current (Average Power Supply Current)	MB81F16822D-102L	I_{CC1S}	Burst: Length=4, t_{RC} = min for BL=4, t_{CK}=min. One bank active, Outputs open, Addresses changed up to 3-times during t_{RC}(min), $0\,V \le V_{IN} \le V_{CC}$	—	110	mA
	MB81F16822D-103L				110	
	MB81F16822D-10L				90	
	MB81F16822D-102L	I_{CC1D}	Burst Length = 4 (each bank), t_{RC} = min for BL=4 (each bank), t_{CK}=min. All banks active, Output open, Addresses changed up to 3-times during t_{RC}(min), $0\,V \le V_{IN} \le V_{CC}$	—	160	mA
	MB81F16822D-103L				160	
	MB81F16822D-10L				130	
Precharge Standby Current (Power Supply Current)		I_{CC2P}	$CKE = V_{IL}$, All banks idle, t_{CK} = min, Power down mode, $0\,V \le V_{IN} \le V_{CC}$	—	150	µA
		I_{CC2PS}	$CKE = V_{IL}$, All banks idle, CLK = H or L, Power down mode, $0\,V \le V_{IN} \le V_{CC}$		150	
		I_{CC2N}	$CKE = V_{IH}$, All banks idle, t_{CK} = min, NOP commands only, Input signals(except to CMD) are changed one times during 3 clock cycles, $0\,V \le V_{IN} \le V_{CC}$	—	20	mA
		I_{CC2NS}	$CKE = V_{IH}$, All banks idle, CLK = H or L, Input signals are stable, $0\,V \le V_{IN} \le V_{CC}$	—	10	

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(Continued)

Parameter	Symbol	Conditions	Value		Unit
			Min.	Max.	
Active Standby Current (Power Supply Current)	I_{CC3P}	$CKE = V_{IL}$, Any bank active, $t_{CK} = min$, $0\,V \leq V_{IN} \leq V_{CC}$	—	5	mA
	I_{CC3PS}	$CKE = V_{IL}$, Any bank active, $CLK = H$ or L, $0\,V \leq V_{IN} \leq V_{CC}$	—	3	mA
Active Standby Current (Power Supply Current)	I_{CC3N}	$CKE = V_{IH}$, Any bank active, $t_{CK} = min$, NOP commands only, Input signals (except to CMD) are changed one times during 3 clock cycles, $0\,V \leq V_{IN} \leq V_{CC}$	—	35	mA
	I_{CC3NS}	$CKE = V_{IH}$, Any bank active, $CLK = H$ or L, $0\,V \leq V_{IN} \leq V_{CC}$	—	20	mA
Burst mode Current (Average Power Supply Current)	I_{CC4}	$t_{CK} = min$, Burst Length = 4, Outputs open, Multiple-banks active, Gapless data, $0\,V \leq V_{IN} \leq V_{CC}$	—	85	mA
Refresh Current #1 (Average PowerSupply Current)	I_{CC5}	Auto-refresh; $t_{CK} = min$, $t_{RC} = min$, $0\,V \leq V_{IN} \leq V_{CC}$	—	80	mA
Refresh Current #2 (Average Power Supply Current)	I_{CC6}	Self-refresh; $t_{CK} = min$, $CKE \leq 0.2\,V$, $0\,V \leq V_{IN} \leq V_{CC}$	—	250	μA
Refresh Current #2 (Average Power Supply Current)	I_{CC6A}	Asynchronous Self-refresh (by CLK stop); $CKE \leq 0.2\,V$, $CLK = V_{IL}$, $0\,V \leq V_{IN} \leq V_{CC}$	—	250	μA

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■ AC CHARACTERISTICS
(At recommended operating conditions unless otherwise noted.)   Notes 2, 3, 4

Parameter Notes		Symbol	MB81F16822D-102L		MB81F16822D-103L		MB81F16822D-10L		Unit
			Min.	Max.	Min.	Max.	Min.	Max.	
Clock Period	CAS Latency = 2	t_{CK2}	10	—	12	—	15	—	ns
	CAS Latency = 3	t_{CK3}	10	—	10	—	10	—	ns
Clock High Time		t_{CH}	3	—	3	—	3	—	ns
Clock Low Time		t_{CL}	3	—	3	—	3	—	ns
Input Setup Time		t_{SI}	2	—	2	—	2	—	ns
Input Hold Time		t_{HI}	1	—	1	—	1	—	ns
Access Time from Clock (t_{CK} = min) *5,6	CAS Latency = 2	t_{AC2}	—	6	—	7	—	8	ns
	CAS Latency = 3	t_{AC3}	—	6	—	6	—	6	ns
Output in Low-Z		t_{LZ}	0	—	0	—	0	—	ns
Output in High-Z *7	CAS Latency = 2	t_{HZ2}	3	6	3	7	3	8	ns
	CAS Latency = 3	t_{HZ3}	3	6	3	6	3	6	ns
Output Hold Time	CAS Latency = 2	t_{OH}	3	—	3	—	3	—	ns
	CAS Latency = 3		3	—	3	—	3	—	ns
Time between Auto-refresh command Interval		t_{REFI}	—	15.6	—	15.6	—	15.6	μs
CKE Low(or CLK Low) Hold Time for Asynchronous Self-refresh Entry		t_{ASE}	100	200	100	200	100	200	μs
Transition Time		t_T	0.5	2	0.5	2	0.5	2	ns
CKE Setup time for Power Down Exit		t_{CKSP}	3	—	3	—	3	—	ns

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BASE VALUES FOR CLOCK COUNT/LATENCY

Parameter	Notes	Symbol	MB81F16822D -102L Min.	MB81F16822D -102L Max.	MB81F16822D -103L Min.	MB81F16822D -103L Max.	MB81F16822D -10L Min.	MB81F16822D -10L Max.	Unit
$\overline{RAS}$ Cycle Time	*8	t_{RC}	70	—	70	—	80	—	ns
$\overline{RAS}$ Precharge Time		t_{RP}	20	—	20	—	30	—	ns
$\overline{RAS}$ Active Time		t_{RAS}	50	110000	50	110000	50	110000	ns
$\overline{RAS}$ to $\overline{CAS}$ Delay Time	*9	t_{RCD}	20	—	20	—	30	—	ns
Write Recovery Time		t_{WR}	10	—	10	—	10	—	ns
Data-in to Precharge Lead Time		t_{DPL}	10	—	10	—	10	—	ns
Data-in to Active/Refresh Command Period — CAS Latency = 2		t_{DAL2}	1cyc+t_{RP}	—	1cyc+t_{RP}	—	1cyc+t_{RP}	—	ns
Data-in to Active/Refresh Command Period — CAS Latency = 3		t_{DAL3}	2cyc+t_{RP}	—	2cyc+t_{RP}	—	2cyc+t_{RP}	—	ns
Mode Register Set Cycle Time		t_{RSC}	20	—	20	—	20	—	ns
$\overline{RAS}$ to $\overline{RAS}$ Bank Active Delay Time		t_{RRD}	20	—	20	—	20	—	ns

CLOCK COUNT FORMULA   Note10

$$\text{Clock} \geq \frac{\text{Base Value}}{\text{Clock Period}} \quad \text{(Round off a whole number)}$$

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LATENCY-FIXED VALUES

(The latency values on these parameters are fixed regardless of clock period.)

Parameter	Notes	Symbol	MB81F16822D-102L	MB81F16822D-103L	MB81F16822D-10L	Unit
CKE to Clock Disable		I_{CKE}	1	1	1	cycle
DQM to Output in High-Z		I_{DQZ}	2	2	2	cycle
DQM to Input Data Delay		I_{DQD}	0	0	0	cycle
Last Output to Write Command Delay		I_{OWD}	2	2	2	cycle
Write Command to Input Data Delay		I_{DWD}	0	0	0	cycle
Precharge to Output in High-Z Delay	CL = 2	I_{ROH2}	2	2	2	cycle
	CL = 3	I_{ROH3}	3	3	3	cycle
Burst Stop Command to Output in High-Z Delay	CL = 2	I_{BSH2}	2	2	2	cycle
	CL = 3	I_{BSH3}	3	3	3	cycle
$\overline{CAS}$ to $\overline{CAS}$ Delay (min)		I_{CCD}	1	1	1	cycle
$\overline{CAS}$ Bank Delay (min)		I_{CBD}	1	1	1	cycle

Notes: *1. I_{CC} depends on the output termination or load conditions, clock cycle rate, and signal clocking rate; the specified values are obtained with the output open and no termination register.

*2. An initial pause (DESL or NOP) of 200 μs is required after power-up followed by a minimum of eight Auto-refresh cycles.

*3. AC characteristics assume t_T = 1 ns and 50 pF of capacitive load.

*4. 1.4 V is the reference level for measuring timing of input signals. Transition times are measured between V_{IH} (min) and V_{IL} (max).

*5. Assumes t_{RCD} is satisfied.

*6. t_{AC} also specifies the access time at burst mode.

*7. Specified where output buffer is no longer driven.

*8. Actual clock count of t_{RC} (I_{RC}) will be sum of clock count of t_{RAS} (I_{RAS}) and t_{RP} (I_{RP}).

*9. Operation within the t_{RCD} (min) ensures that access time is determined by t_{RCD}(min) + t_{AC}(max); If t_{RCD} is greater than the specified t_{RCD} (min), access time is determined by t_{AC}.

*10. All base values are measured from the clock edge at the command input to the clock edge for the next command input. All clock counts are calculated by a simple formula:
  clock count equals base value divided by clock period (round off to a whole number).

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Fig. 4 – EXAMPLE OF AC TEST LOAD CIRCUIT

Output

$R_1 = 50\ \Omega$

1.4 V

$C_L = 50\ pF$

LVTTL
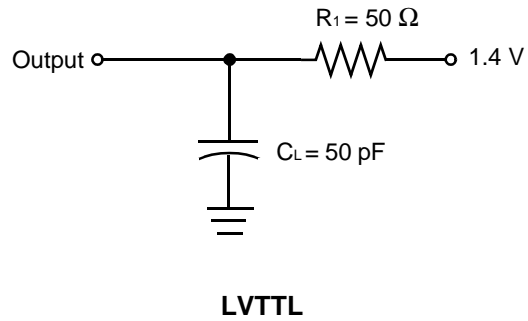
Note: AC characteristics are measured in this condition. This load circuits are not applicable for V_{OH} and V_{OL}.

Fig. 5 – TIMING DIAGRAM, SETUP, HOLD AND DELAY TIME
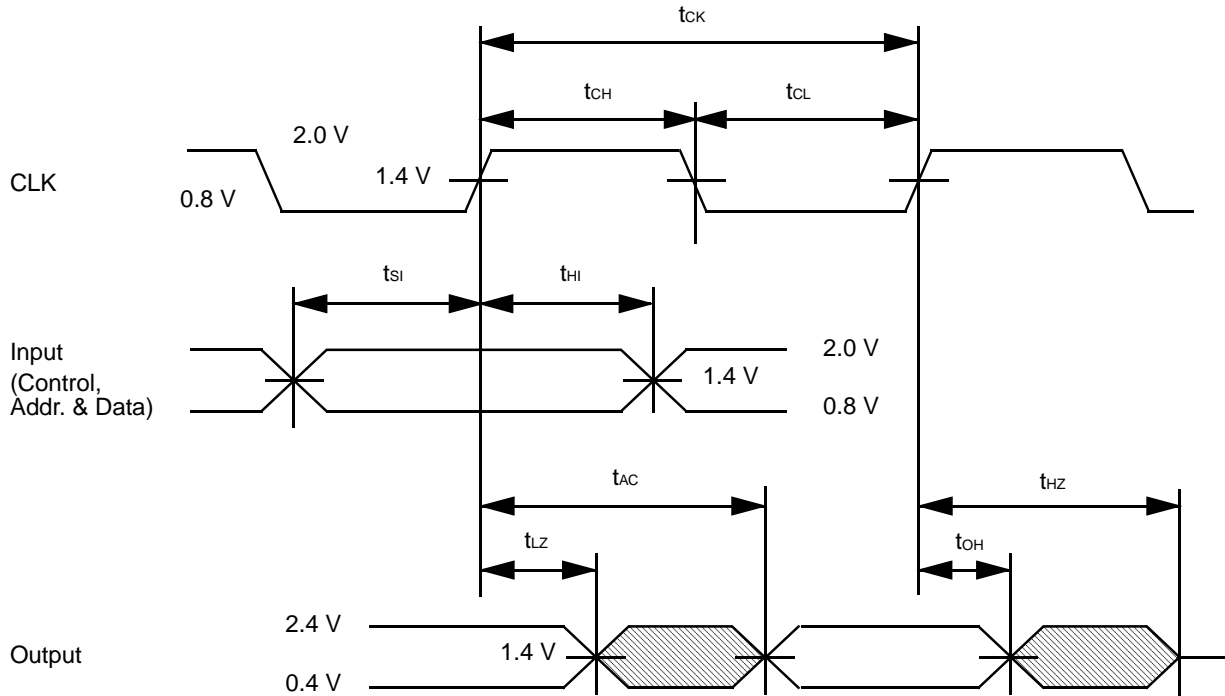
Note: Reference level of input signal is 1.4 V for LVTTL.
Access time is measured at 1.4 V for LVTTL.

Fig. 6 – TIMING DIAGRAM, DELAY TIME FOR POWER DOWN EXIT
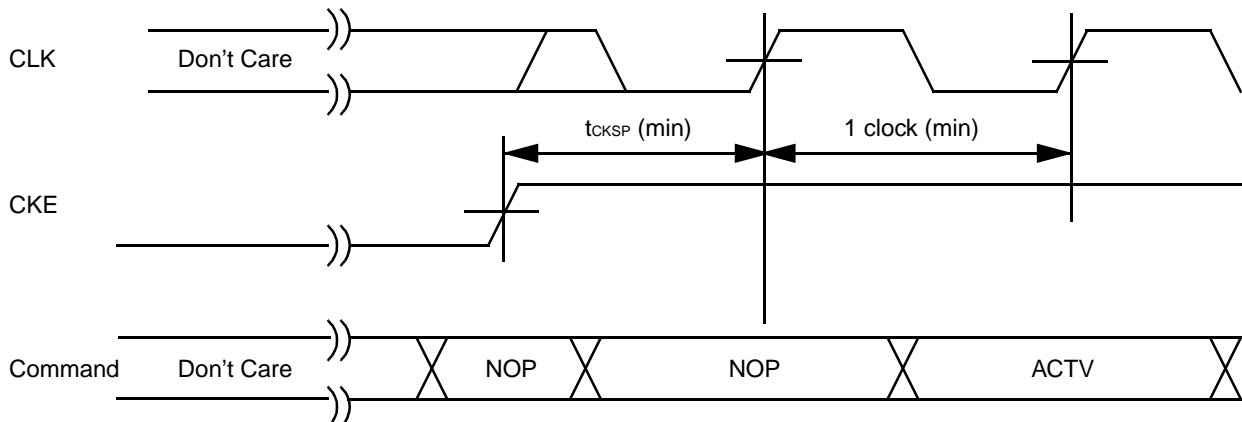
MB81F16822D-102L/-103L/-10L

Fig. 7 – TIMING DIAGRAM, PULSE WIDTH

CLK

t_{RC}, t_{RP}, t_{RAS}, t_{RCD}, t_{WR}, t_{REFI}, t_{DPL}, t_{DAL}, t_{RSC}, t_{RRD}, t_{CKSP}

Input
(Control)   Command   Command
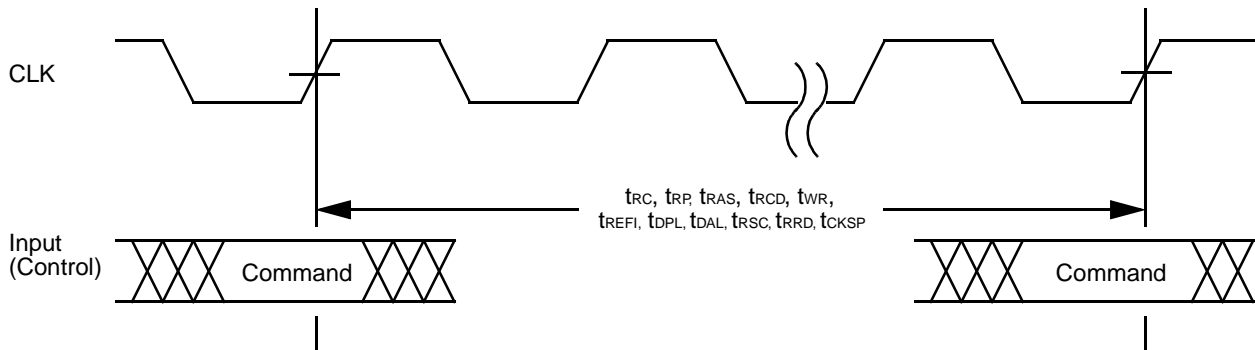
Note: These parameter are a limit value of the rising edge of the clock from one command input to next input. t_{CKSP} is the latency value from the rising edge of CKE.
Measurement reference voltage is 1.4 V.

Fig. 8 – TIMING DIAGRAM, ACCESS TIME

CLK

t_{RAC}

$\overline{RAS}$

t_{RCD} t_{CAC}

$\overline{CAS}$

(CAS Latency – 1) $\times$ t_{CK} t_{AC}

DQ
(Output)   Q(Valid)
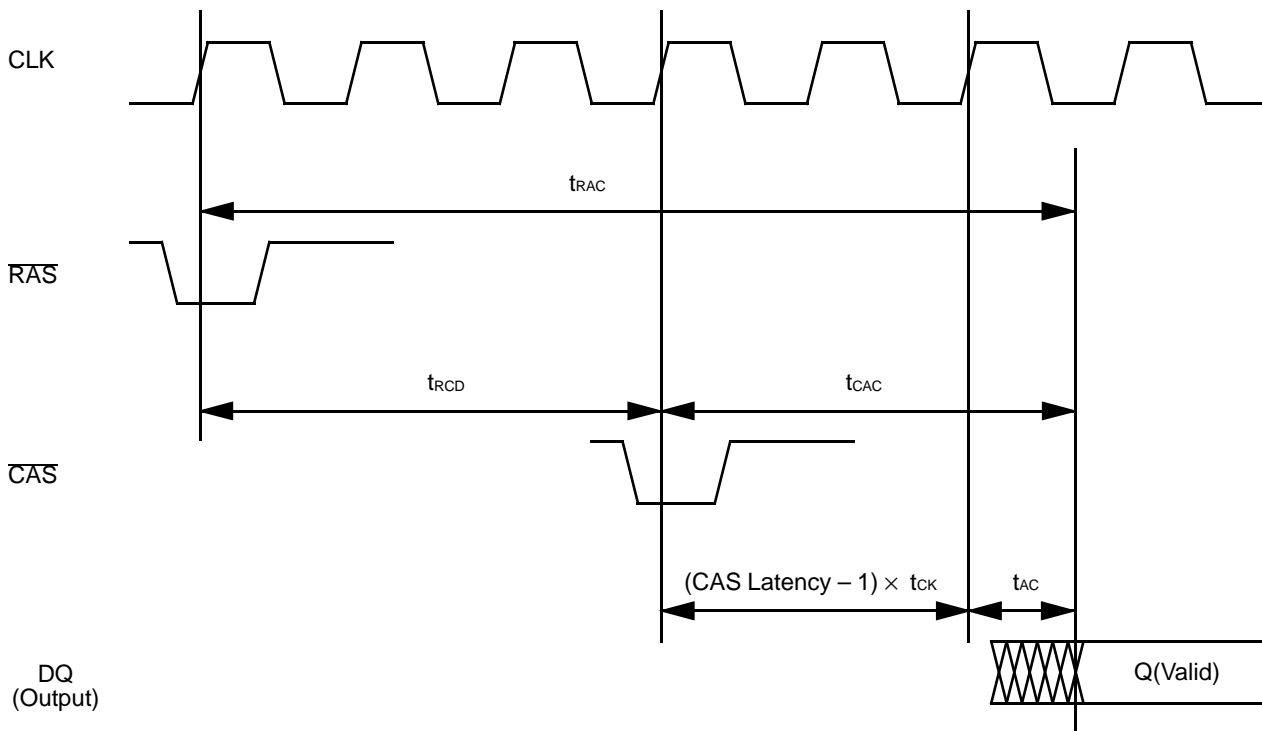
Note: t_{RAC}, t_{CAC} are a reference value. Data can be obtained after both $t_{CAC}=(CL-1)\times t_{CK}$ and t_{AC} are satisfied.

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■ MODE REGISTER TABLE

MODE REGISTER SET

A_{11}	A_{10}	A_9	A_8	A_7	A_6	A_5	A_4	A_3	A_2	A_1	A_0	ADDRESS
0	0	Op-code	0	0		CL		BT		BL		MODE REGISTER

A_6	A_5	A_4	CAS Latency
0	0	0	Reserved
0	0	1	Reserved
0	1	0	2
0	1	1	3
1	0	0	Reserved
1	0	1	Reserved
1	1	0	Reserved
1	1	1	Reserved

A_2	A_1	A_0	Burst Length	
			BT = 0	BT = 1
0	0	0	1	Reserved
0	0	1	2	2
0	1	0	4	4
0	1	1	8	8
1	0	0	Reserved	Reserved
1	0	1	Reserved	Reserved
1	1	0	Reserved	Reserved
1	1	1	Full Column	Reserved

A_9	Op-code
0	Burst Read & Burst Write
1	Burst Read & Single Write

A_3	Burst Type
0	Sequential (Wrap round, Binary-up)
1	Interleave (Wrap round, Binary-up)

Notes: 1. When A_9 = 1, burst length at Write is always one regardless of BL value.
2. BL = 1 and Full Column are not applicable to the interleave mode.

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TIMING DIAGRAM - 1 : CLOCK ENABLE - READ AND WRITE SUSPEND (@ BL = 4)

CLK

CKE

I_{CKE} (1 clock) *1 I_{CKE} (1 clock) *1

CLK
(Internal)   *2   *2

DQ
(Read)   Q1   Q2   (No Change)*2   Q3   (No Change)*2   Q4

DQ
(Write)   D1   Not Written*3   D2   Not Written*3   D3   D4
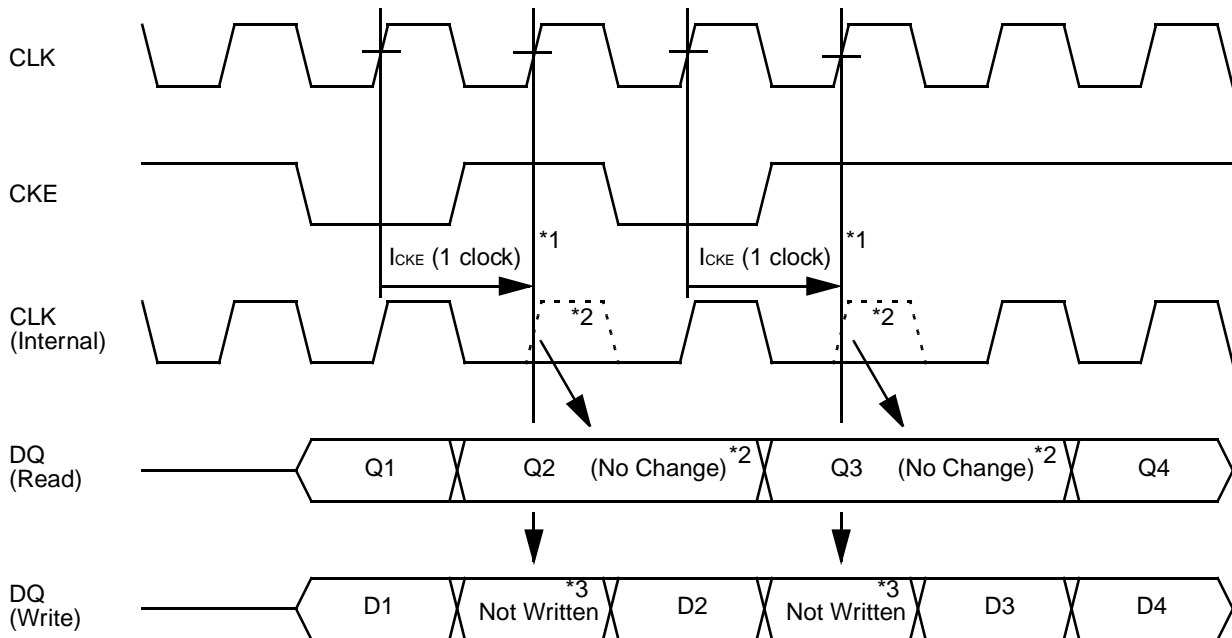
Notes: *1. The latency of CKE (I_{CKE}) is one clock.
*2. During read mode, burst counter will not be incremented/decremented at the next clock of CSUS command. Output remain the same data.
*3. During the write mode, data at the next clock of CSUS command is ignored.

TIMING DIAGRAM - 2 : CLOCK ENABLE - POWER DOWN ENTRY AND EXIT

CLK

t_{CKSP} 1 clock (min)

CKE

Command   NOP *1   PD(NOP)*2   Don't Care   NOP *3   NOP *3   ACTV

t_{REF} (max)
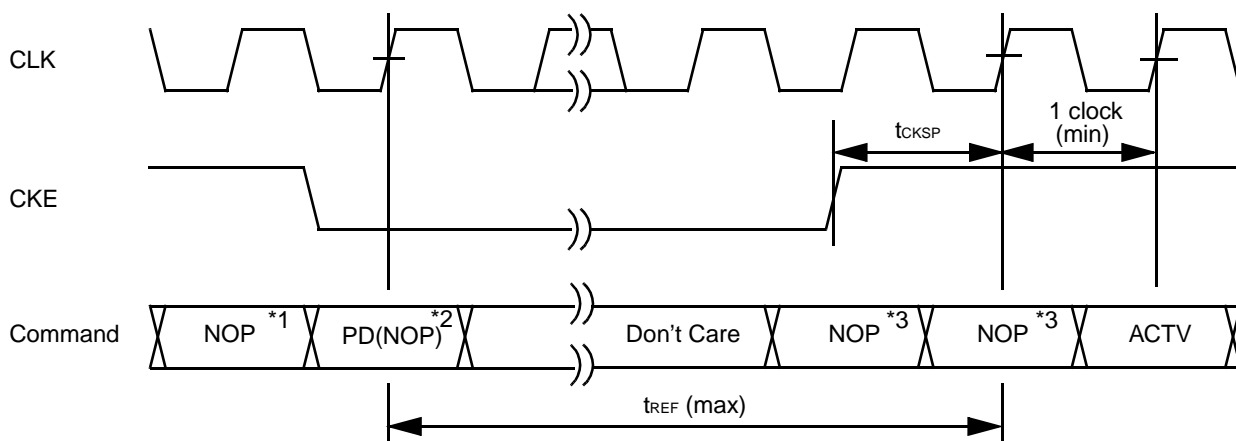
Notes: *1. Precharge command (PRE or PALL) should be asserted if any bank is active and in the burst mode.
*2. Precharge command can be posted in conjunction with CKE when burst mode is ended at this clock.
*3. The ACTV command can be latched after t_{CKSP} (min) + 1clock (min). It is should be asserted NOP command in conjunction with CKE.

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TIMING DIAGRAM - 3 : COLUMN ADDRESS TO COLUMN ADDRESS INPUT DELAY

CLK

$\overline{RAS}$

t_{RCD} (min) I_{CCD} (1 clock) I_{CCD} I_{CCD} I_{CCD}

$\overline{CAS}$

Address: Row Address | Column Address | Column Address | Column Address | Column Address | Column Address
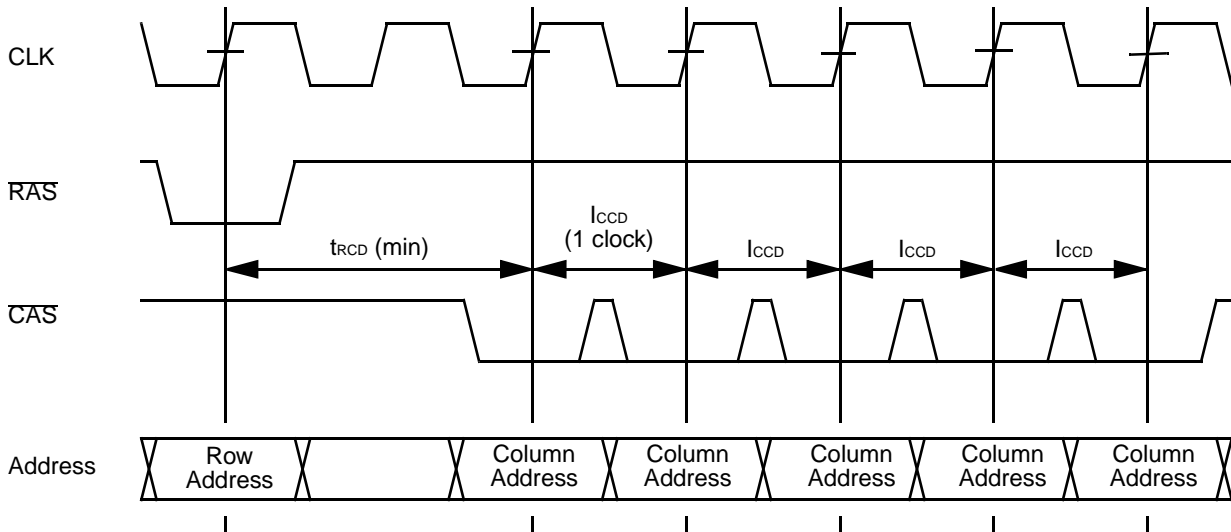
Note: $\overline{CAS}$ to $\overline{CAS}$ address delay can be one or more clock period.

TIMING DIAGRAM - 4 : DIFFERENT BANK ADDRESS INPUT DELAY

CLK

t_{RRD} (min)

$\overline{RAS}$

t_{RCD} (min) I_{CBD} I_{CBD}

$\overline{CAS}$

t_{RCD} (min)

Address: Row Address | Row Address | Column Address | Column Address | Column Address | Column Address

A_{11}(BA): Bank 0 | Bank 1 | Bank 0 | Bank 1 | Bank 0 | Bank 1
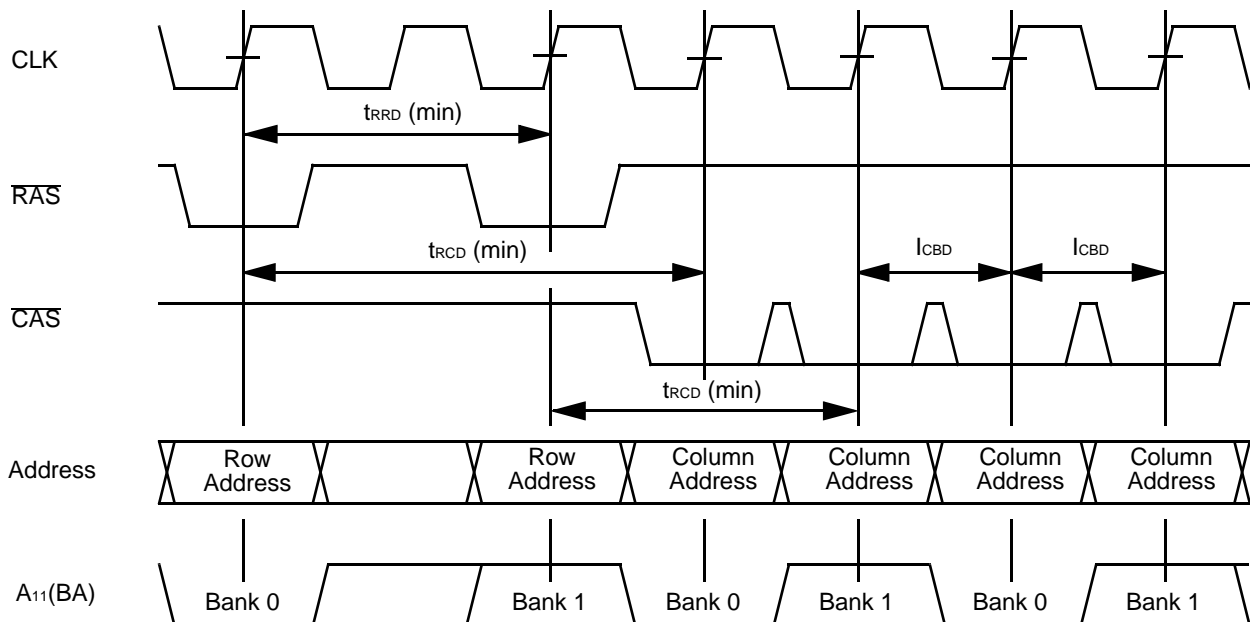
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TIMING DIAGRAM - 5 : DQM-INPUT MASK AND OUTPUT DISABLE (@ BL = 4)

CLK

DQM
(@ Read)

I_{DQZ} (2 clocks)

DQ
(@ Read)   Q1   Q2   Hi-Z   Q4   End of burst

DQM
(@ Write)

I_{DQD} (same clock)

DQ
(@ Write)   D1   Masked   D3   D4   End of burst
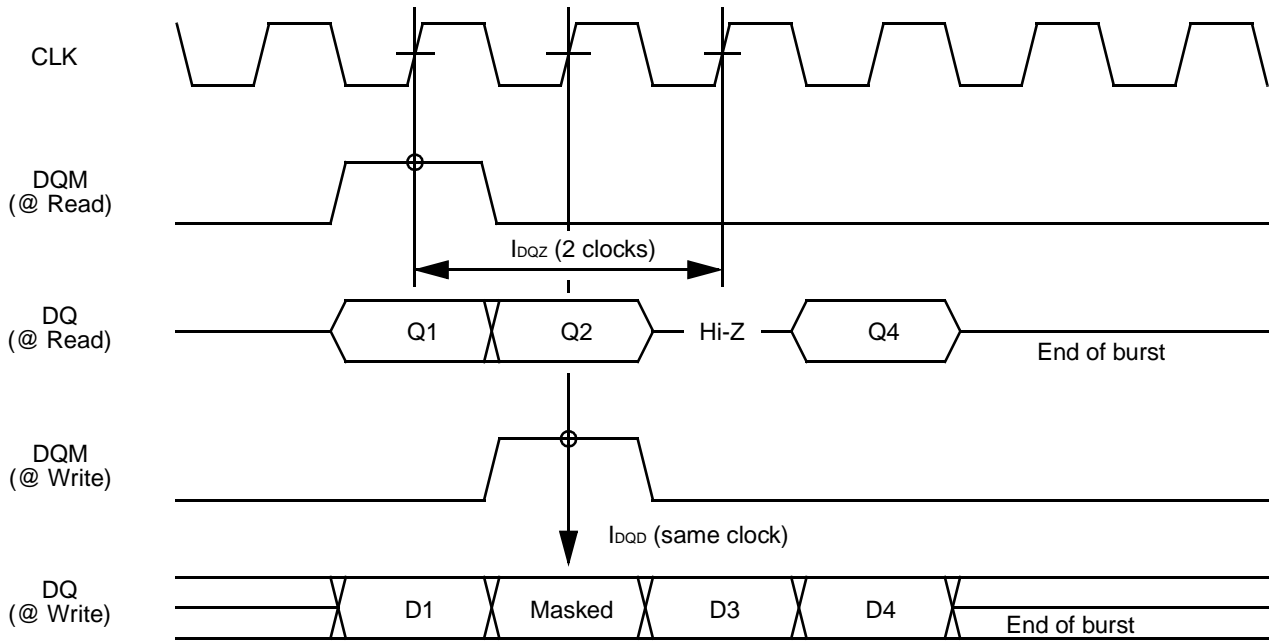
TIMING DIAGRAM - 6 : PRECHARGE TIMING (APPLIED TO THE SAME BANK)

CLK

t_{RAS} (min)

Command   ACTV   Precharge

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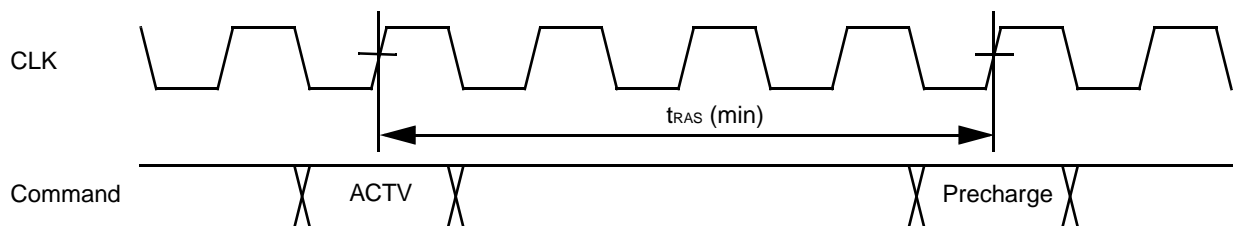
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TIMING DIAGRAM - 7 : READ INTERRUPTED BY PRECHARGE (Example @ CL = 2, BL = 4)

CLK

Command — Precharge

I_{ROH} (2 clocks)

DQ — Q1 — Hi-Z

Command — Precharge

I_{ROH} (2 clocks)

DQ — Q1 Q2 — Hi-Z

Command — Precharge

I_{ROH} (2 clocks)

DQ — Q1 Q2 Q3 — Hi-Z

Command — Precharge

No effect (end of burst)

DQ — Q1 Q2 Q3 Q4
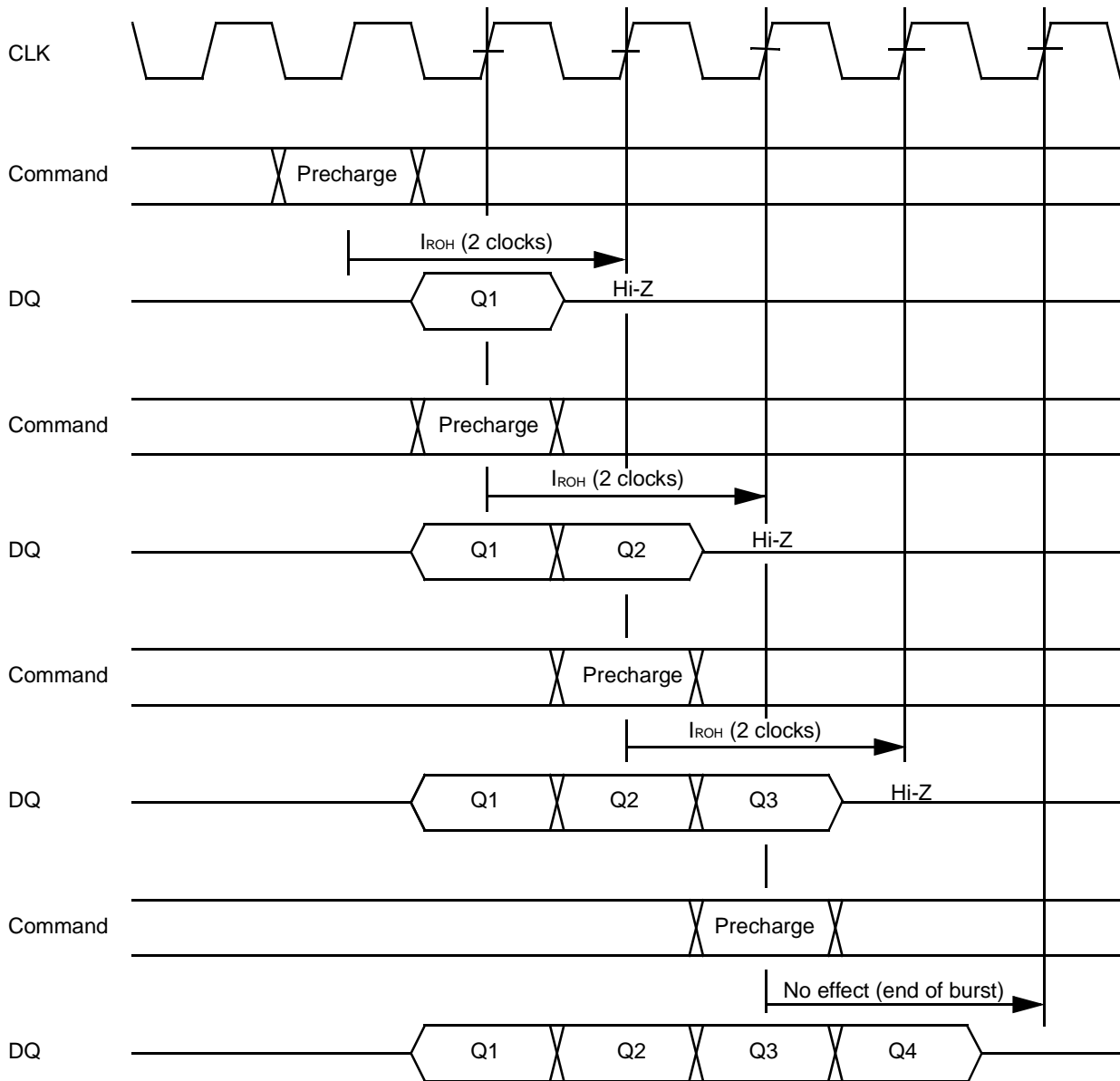
Note: In case of CL = 2, the I_{ROH} is 2 clock.
In case of CL = 3, the I_{ROH} is 3 clock.

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TIMING DIAGRAM - 8 : READ INTERRUPTED BY BURST STOP (Example @ BL = Full Column)
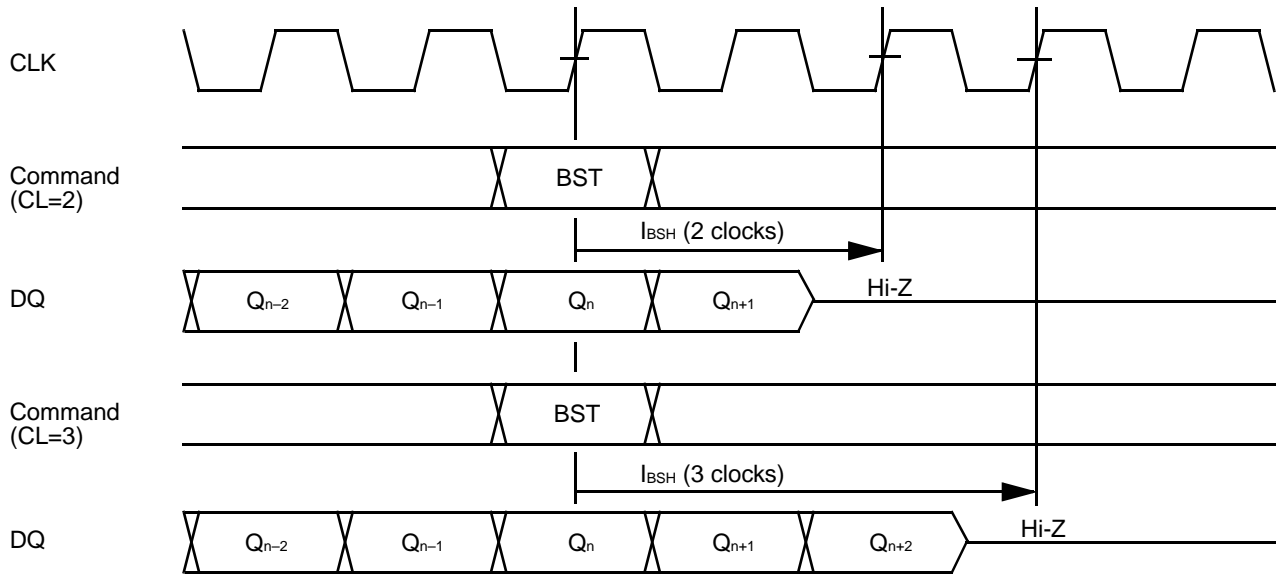
Note: The selection of Auto-precharge option is illegal during the full column burst operation except Write command at BURST READ & SINGLE WRITE mode.

TIMING DIAGRAM - 9 : WRITE INTERRUPT BY BURST STOP (Example @ CL = 2)
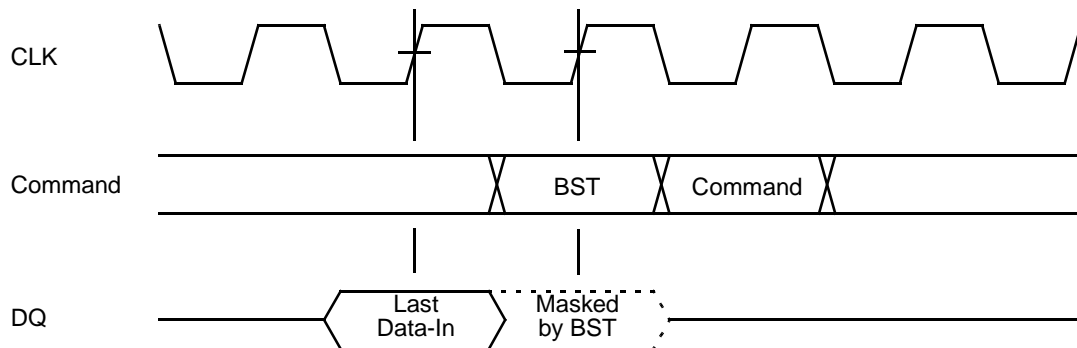
MB81F16822D-102L/-103L/-10L

TIMING DIAGRAM - 10 : WRITE INTERUPTED BY PRECHARGE (Example @ CL = 3)

CLK

Command   Precharge   Active

t_{DPL}(min) t_{RP}(min)

DQ   Data-In   Last Data-In   Masked by PRE
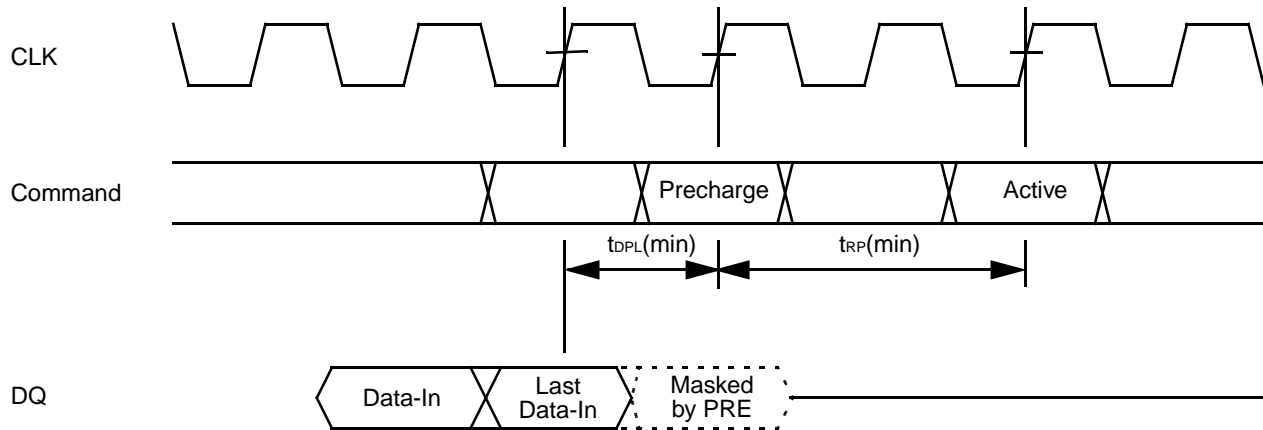
Note: The precharge command (PRE) should only be issued after the t_{DPL} of final data input, is satisfied.

TIMING DIAGRAM - 11 : READ INTERRUPTED BY WRITE (Example @ CL = 3, BL = 4)

CLK

I_{OWD} (2 clocks)

Command   Read   Write

DQM   Note 1   Note 2   Note 3

I_{DQZ} (2 clocks) I_{DWD} (same clock)

DQ   Data Out   Masked   Data In   Data In
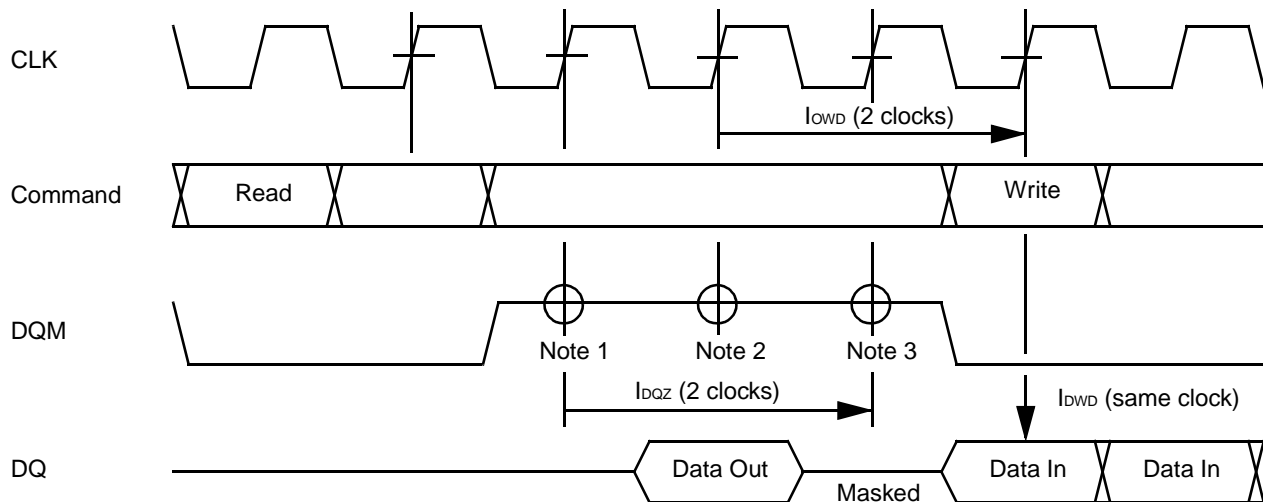
Notes: 1. First DQM makes high-impedance state High-Z between last output and first input data.
2. Second DQM makes internal output data mask to avoid bus contention.
3. Third DQM in illustrated above also makes internal output data mask. If burst read ends (final data output) at or after the second clock of burst write, this third DQM is required to avoid internal bus contention.

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TIMING DIAGRAM - 12 : WRITE TO READ TIMING (Example @ CL = 3, BL = 4)

CLK

t_{WR} (min)

Command — Write — Read

DQM

(CL-1) x t_{CK} t_{AC} (max)

DQ — D1 — D2 — D3 Masked by Read — Q1 — Q2
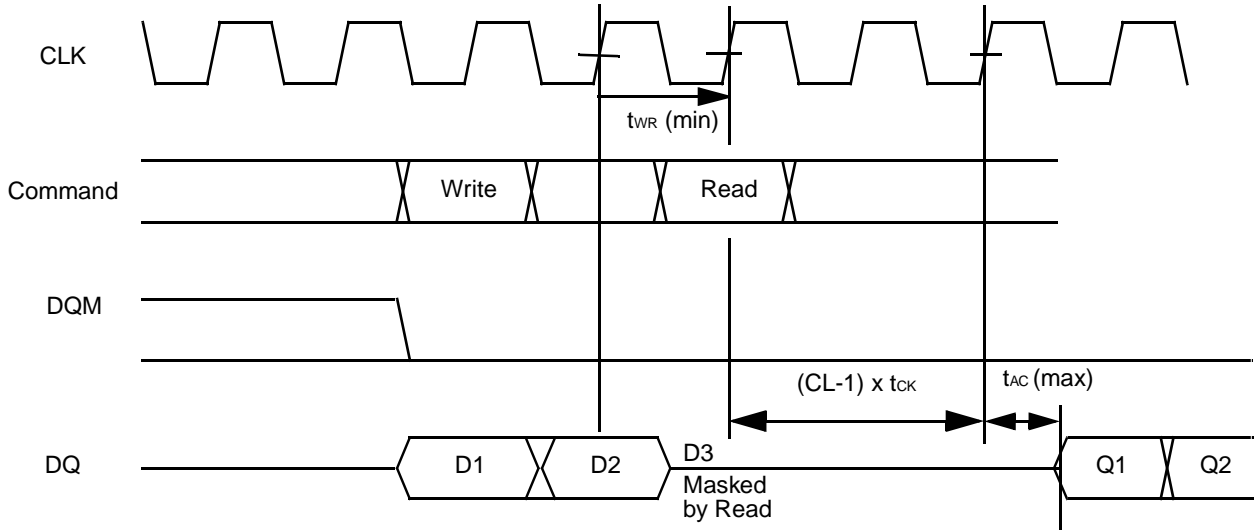
Note: Read command should be issued after t_{WR} of final data input is satisfied if read command is applied to the same bank.

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TIMING DIAGRAM - 13 : READ WITH AUTO-PRECHARGE
(Example @ CL = 2, BL = 2 Applied to same bank)
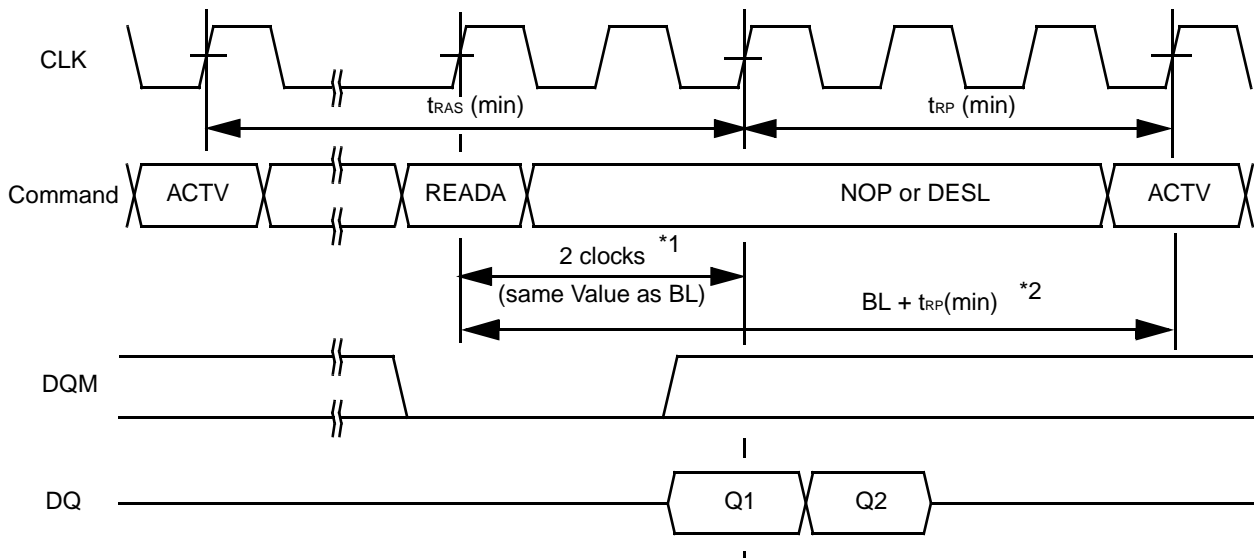
Notes: *1. Precharge at read with Auto-precharge command (READA) is started from number of clocks that is the same as Burst Length (BL) after READA command is asserted.
*2. Next ACTV command should be issued after BL + tRP(min) from READA command.

TIMING DIAGRAM - 14 : WRITE WITH AUTO-PRECHARGE
(Example @ CL = 2, BL = 2 Applied to same bank)
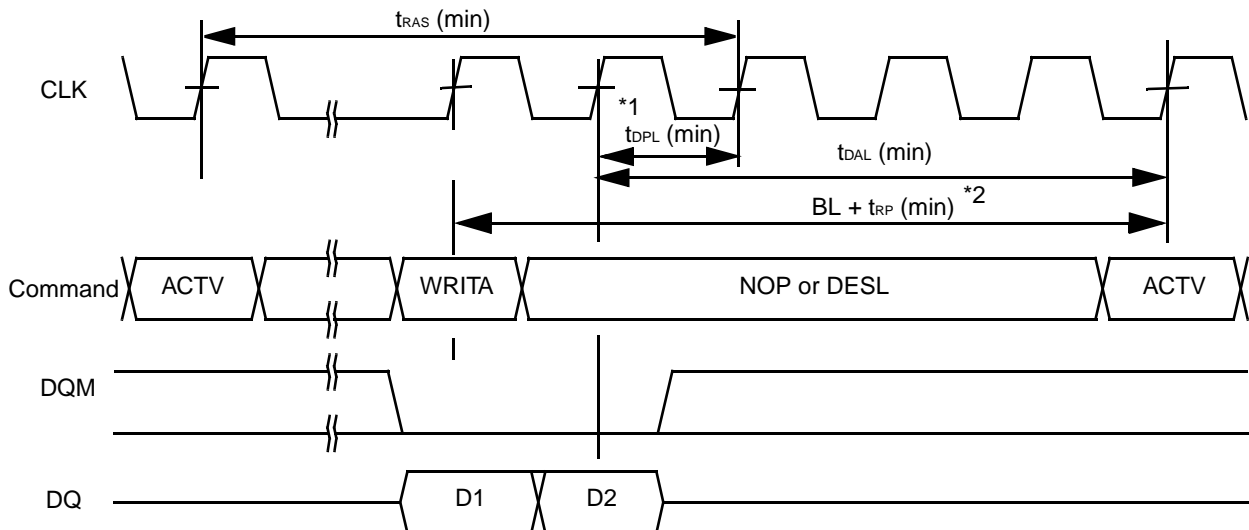
Notes: *1. Precharge at write with Auto-precharge is started after the t_{DPL} from the end of burst.
*2. Even if the final data is masked by DQM, the precharge does not start the clock of final data input.
*3. Once auto precharge command is asserted, no new command within the same bank can be issued.
*4. Auto-precharge command doesn't affect at full column burst operation except Burst Read & Single Write mode.
*5. Next command should be issued after BL + tRP (min) at CL = 2, BL + 1 + tRP (min) at CL = 3 from WRITEA command.

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TIMING DIAGRAM - 15 : AUTO-REFRESH TIMING
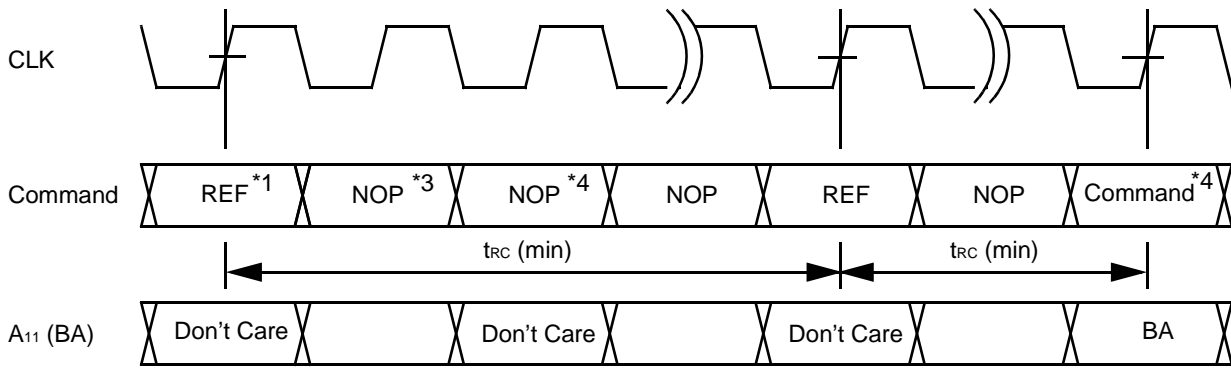
Notes: *1. All banks should be precharged prior to the first Auto-refresh command (REF).
*2. Bank select is ignored at REF command. The refresh address and bank select are selected by internal refresh counter.
*3. Either NOP or DESL command should be asserted during t_{RRD} and t_{RC} period while Auto-refresh mode.
*4. Any activation command such as ACTV or MRS command other than REF command should be asserted after t_{RC} from the last REF command.

TIMING DIAGRAM - 16 : SELF-REFRESH ENTRY AND EXIT TIMING
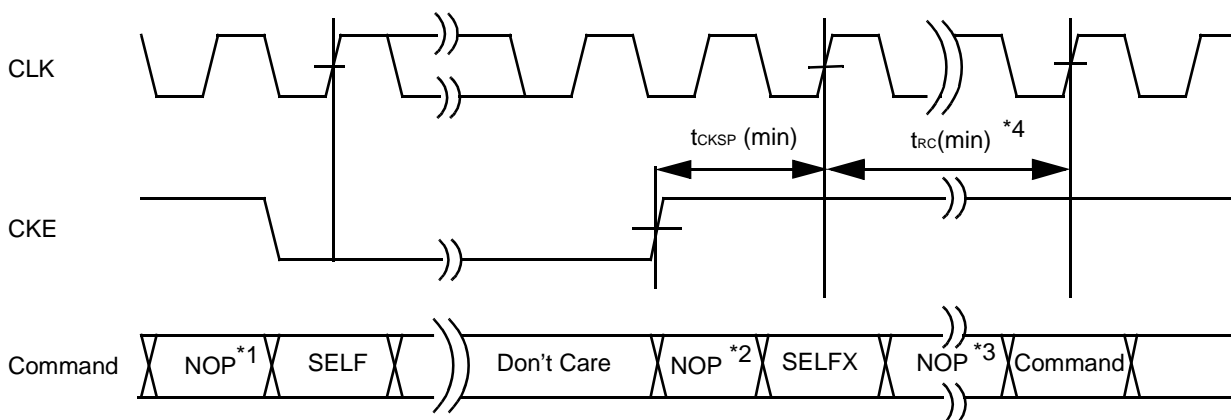
Notes: *1. Precharge command (PRE or PALL) should be asserted if any bank is active prior to Self-refresh Entry command (SELF).
*2. The Self-refresh Exit command (SELFX) is latched after t_{CKSP} (min). It is recommended to apply NOP command in conjunction with CKE. It is also recommended to apply minimum of 4 clocks to stabilize external clock prior to SELFX command.
*3. Either NOP or DESL command can be used during t_{RC} period.
*4. CKE should be held High within t_{RC}(min) period after t_{CKSP}

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TIMING DIAGRAM - 17 : SELF-REFRESH TIMING (Asynchronous Self-refresh)
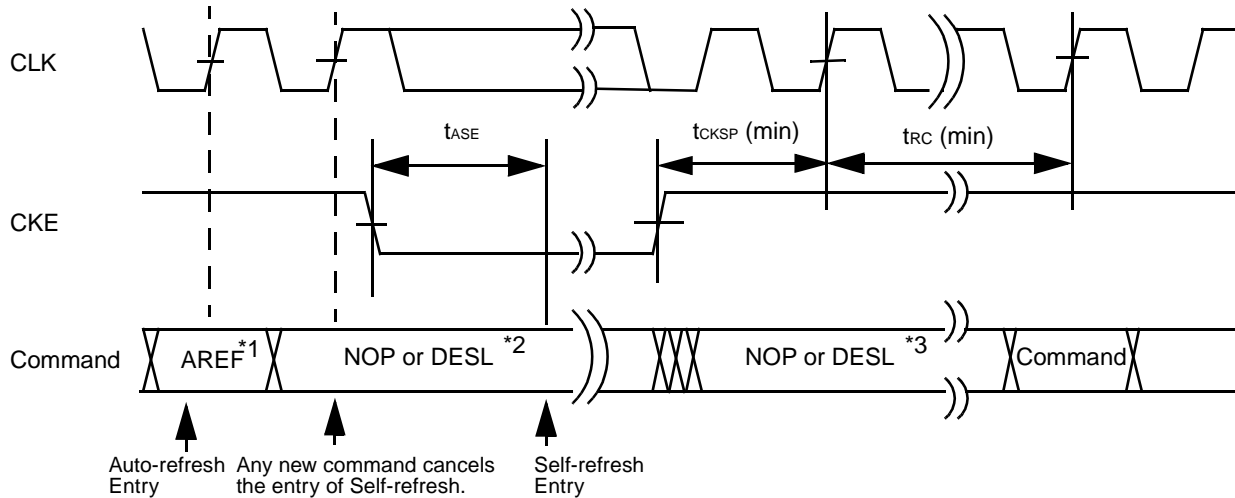
Auto-refresh Entry · Any new command cancels the entry of Self-refresh. · Self-refresh Entry

Notes: *1. Precharge command (PRE or PALL) should be asserted if any bank is active prior to Auto-refresh command (AREF).
   *2. Either NOP or DESL command can be used during t_{RC} period. Applying any command before CKE is brought Low cancenls the entry of Asynchronous Self-refresh.
   *3. Either NOP or DESL command can be used during t_{ASE} period.

TIMING DIAGRAM - 18 : SELF-REFRESH TIMING (Async. Self-refresh)

CLK=Low fixed

Auto-refresh Entry · Self-refresh Entry
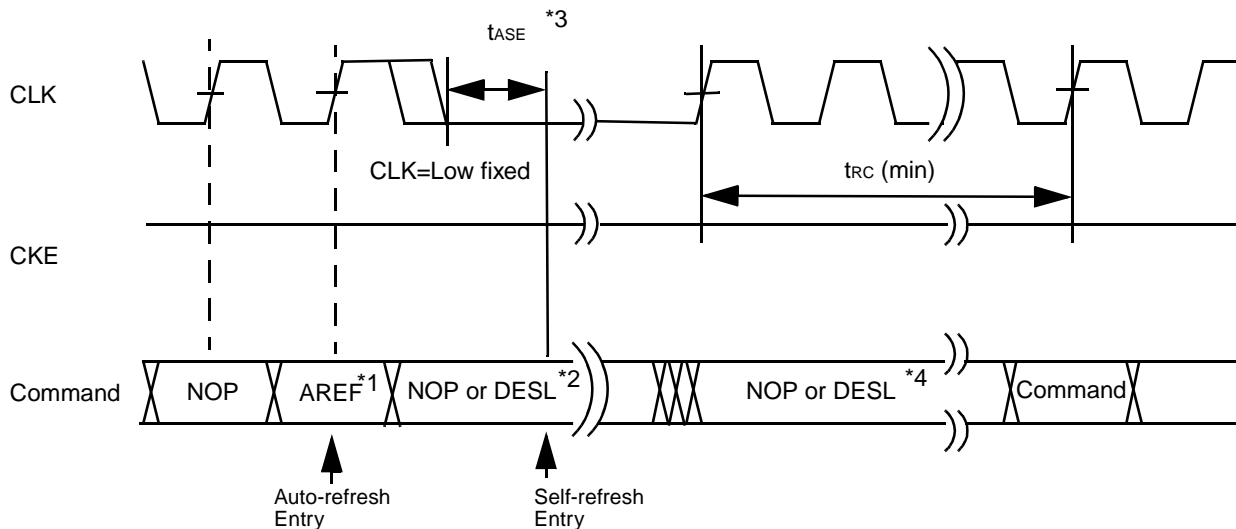
Notes: *1. Precharge command (PRE or PALL) should be issued if any bank is active prior to Auto-refresh command (AREF).
   *2. Either NOP or DESL command must be maintained.
   *3. CLK must stop and be kept at Low in order to enter Asynchronous Self-refresh.
   *4. Either NOP or DESL command can be used during t_{RC} period.

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TIMING DIAGRAM - 19 : SELF-REFRESH TIMING (Async. Self-refresh Cancellation)

CLK

$t_{CKSP(min)}$ *1 t_{RC}

CKE

t_{ASE}

Command   AREF   NOP or DESL   Any *2   NOP *3

Auto-refresh
Entry
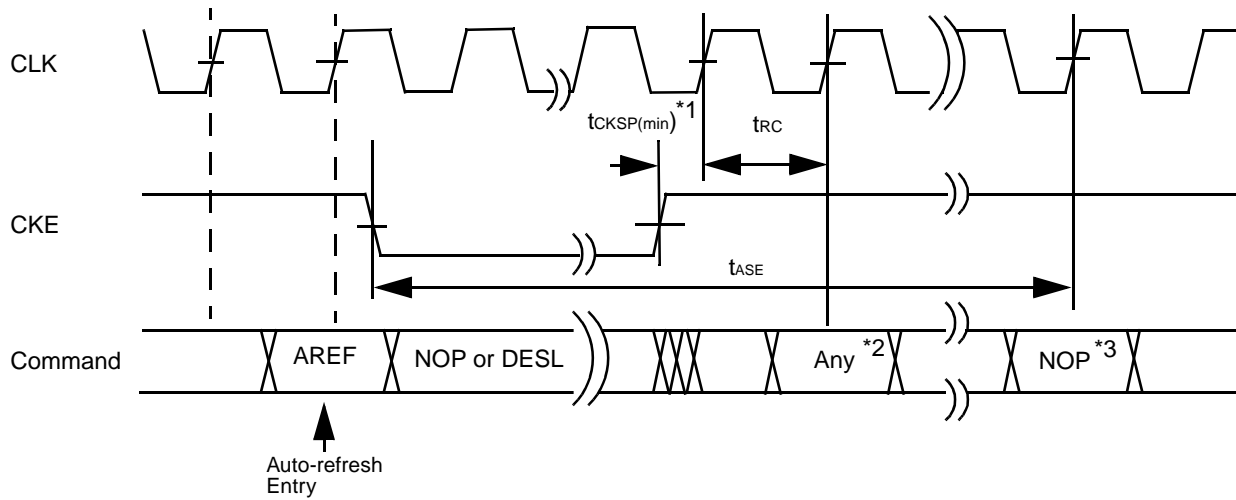
Notes: *1. Simply by turn CKE = High before t_{ASE} (min).
*2. Next commnad can be issued form 1 clock later when t_{CKSP} is satisfied.
*3. Either NOP or DESL command can be used.
*4. The cancellation of Asynchronous Self-refresh entry can be done if CKE is brought to High prior to t_{ASE} (min).

TIMING DIAGRAM - 20 : MODE REGISTER SET TIMING

CLK

t_{RSC}

Command   MRS   NOP or DESL   ACTV

Address   Mode   ROW
Address
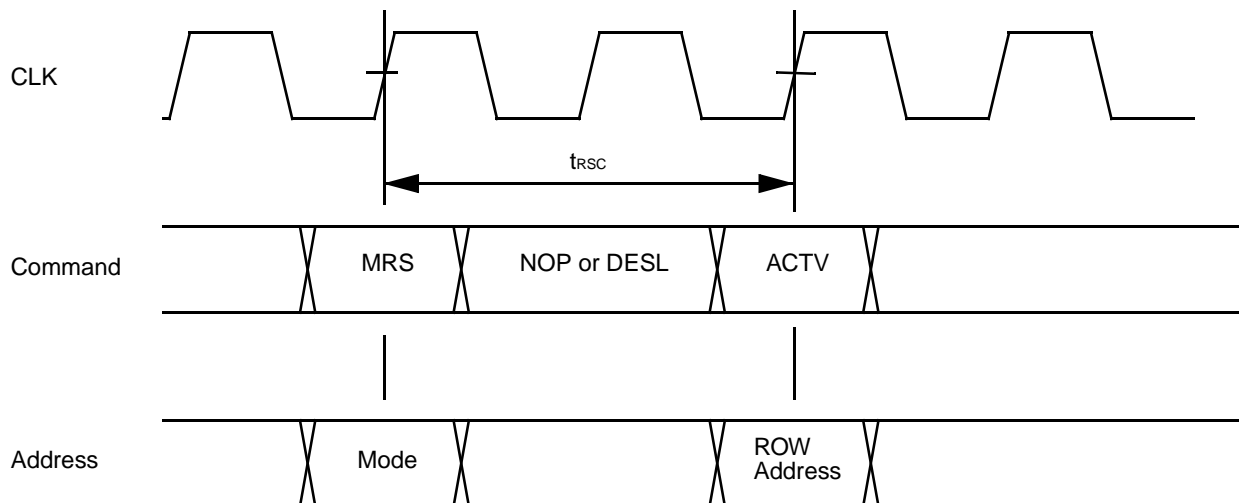
Note: The Mode Register Set command (MRS) should be only asserted after all banks have been precharged.

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■ PACKAGE DIMENSION

44-pin plastic TSOP (II)
(FPT-44P-M18)

∗ : Resin protrusion. (Each side: 0.15(.006)MAX.)

Details of "A" part

0.15(.006)

0.25(.010)

0.10(.004) MAX

0.40(.016) MAX

INDEX

"A"

LEAD No. 1

∗ 18.41±0.10
(.725±.004)

0.30±0.10
(.012±.004)   ⊕ 0.13(.005) Ⓜ

0.80(.031)
TYP.

16.80(.661)
REF.

□ 0.10(.004)

1.15±0.05
(.045±.002)   (Mounting height)

0.05(.002)MIN
(STAND OFF)

11.76±0.20
(.463±.008)

10.16±0.10
(.400±.004)

0.125±0.05
(.005±.002)

0.50±0.10
(.020±.004)

10.76±0.20
(.424±.008)
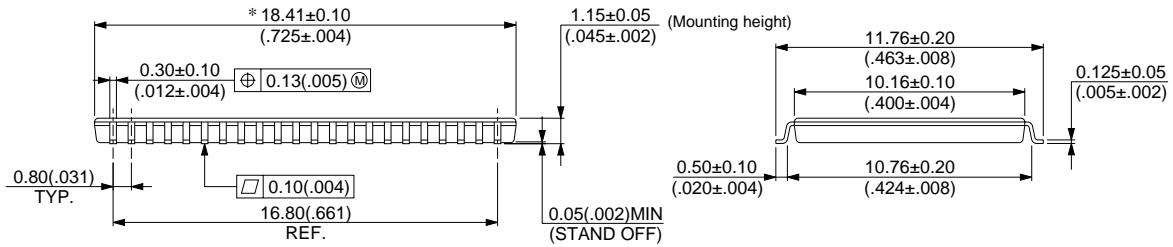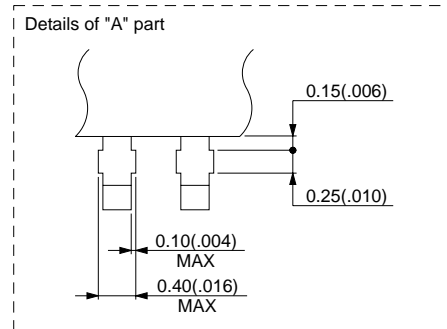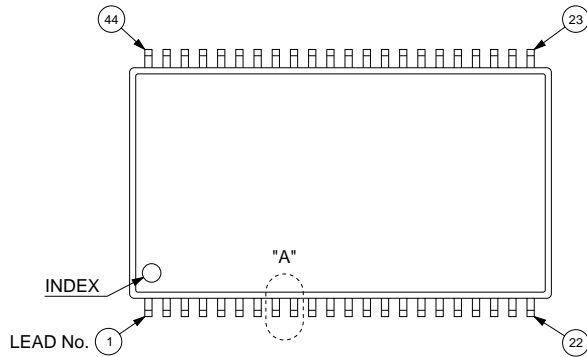
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Dimensions in mm (inches)

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